

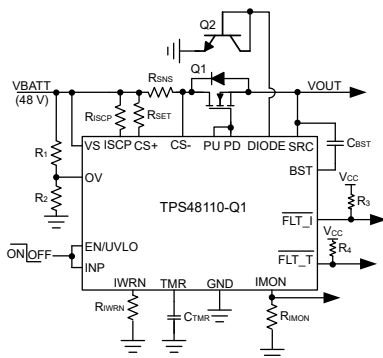
## TPS4811-Q1 具有保护和诊断功能的 100V 汽车智能高侧驱动器

## 1 特性

- 具有符合 AEC-Q100 标准的下列特性
  - 器件温度等级 1：
    - 40°C 至 +125°C 环境工作温度范围
- 功能安全型
  - 可提供用于功能安全系统设计的文档
- 3.5V 至 80V 输入范围 (绝对最大值为 100V)
- 输出反极性保护低至 -30V
- 具有 100μA 容量的集成 12V 电荷泵
- 1.6μA 低关断电流 (EN/UVLO = 低电平)
- 强大的上拉 (3.7A) 和下拉 (4A) 栅极驱动器
- 驱动外部背对背 N 沟道 MOSFET
- 具有集成预充电开关驱动器 (TPS48111-Q1) 以驱动容性负载的型号
- 具有可调断路器计时器 (TMR) 和故障标志输出 (FLT\_I) 的两级可调过流保护 (IWRN、ISCP)
- 快速短路保护：1.2μs (TPS48111-Q1)、4μs (TPS48110-Q1)
- 精确的模拟电流监测输出 (IMON)：
  - 30mV 时为 ±2% (V<sub>SNS</sub>)
- 精确的可调节欠压锁定 (UVLO) 和过压保护 (OV)：
  - < ±2%
- 具有故障标志输出 (FLT\_T) 的远程过热检测 (DIODE)

## 2 应用

- 配电盒
- 车身控制模块
- 直流/直流转换器
- 电池管理系统



适用于加热器负载的智能高侧驱动器

## 3 说明

TPS4811x-Q1 系列是一款具有保护和诊断功能的 100V 智能高侧驱动器。该器件具有 3.5V 至 80V 的宽工作电压范围，适用于 12V、24V 和 48V 系统设计。

它具有强大的 3.7A 峰值拉电流 (PU) 和 4A 峰值灌电流 (PD) 栅极驱动器，可在大电流系统设计中使用时使用并联 FET 进行电源开关。将 INP 用作栅极驱动器控制输入。

该器件具有精确的电流检测 (±2%) 输出 (IMON) 支持系统设计，可用于能源管理。该器件集成了具有 FLT\_I 输出的两级过流保护，具有完全可调的阈值和响应时间。可以配置自动重试和锁存故障行为。该器件具有远程过热保护，具有 FLT\_T 输出。

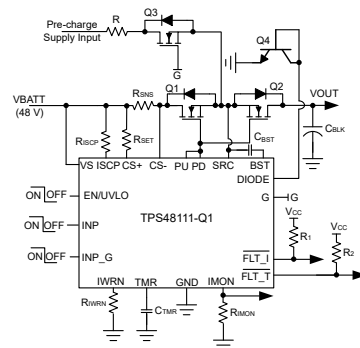
TPS48111-Q1 将预充电驱动器 (G) 与控制输入 (INP\_G) 集成。此功能支持必须驱动大容性负载的设计。在关断模式下，控制器在 48V 电源输入下的总关断电流为 1.6μA。

TPS4811x-Q1 采用 19 引脚 VSSOP 封装，在相邻的高压和低压引脚之间移除了一个引脚，提供 0.8mm 的间隙。

## 封装信息

器件型号	封装 <sup>(1)</sup>	封装尺寸 <sup>(2)</sup>
TPS48110-Q1、TPS48111-Q1	DGX (VSSOP、19)	5.10mm x 3.00mm

- 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。
- 封装尺寸 (长 × 宽) 为标称值，并包括引脚 (如适用)。



用于直流/直流转换器的断路器





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## 4 Device Comparison Table

	TPS48110-Q1	TPS48111-Q1
Overvoltage protection	Yes	No
Pre-charge driver	No	Yes
Short-circuit protection response time	4 $\mu$ s	1.2 $\mu$ s
Overtemperature fault response	Auto-retry with fixed 512-ms timer	Latch-off

## 5 Pin Configuration and Functions

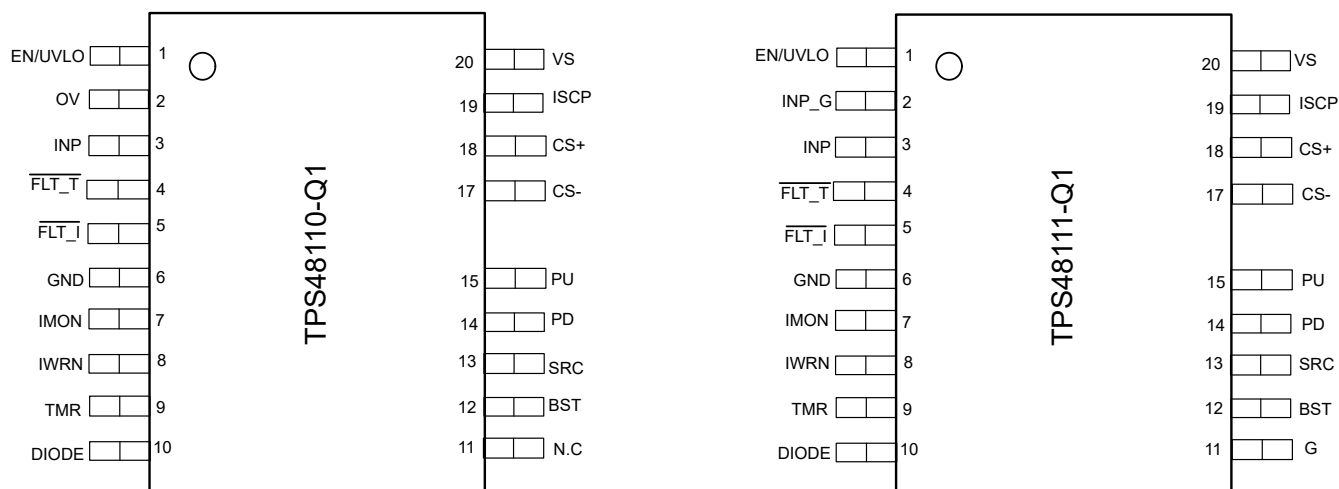


图 5-1. DGX Package, 19-Pin VSSOP (Top View)

表 5-1. Pin Functions

PIN			TYPE	DESCRIPTION
NAME	TPS48110-Q1	TPS48111-Q1		
	DGX-19 (VSSOP)			
EN/UVLO	1	1	I	EN/UVLO input. A voltage on this pin above 1 V enables normal operation. Forcing this pin below 0.3 V shuts down the TPS4811x-Q1, reducing quiescent current to approximately 1.6 μA (typical). Optionally connect to the input supply through a resistive divider to set the undervoltage lockout. When EN/UVLO is left floating an internal pull down of 60 nA pulls EN/UVLO low and keeps the device in OFF state.
OV	2	—	I	Adjustable overvoltage threshold input. Connect a resistor ladder from input supply, OV to GND. When the voltage at OV exceeds the overvoltage cut-off threshold then the PD is pulled down to SRC turning OFF the external FET. When the voltage at OV goes below OV falling threshold then PU gets pulled up to BST, turning ON the external FET. OV must be connected to GND when not used. When OV is left floating an internal pull down of 60 nA pulls OV low and keeps PU pulled up to BST.
INP_G	—	2	I	Input Signal. CMOS compatible input reference to GND that sets the state of G pin. INP_G has an internal pull-down to GND to keep G pulled to SRC when INP_G is left floating. Connect INP_G to GND if the G drive functionality is unused.
INP	3	3	I	Input Signal. CMOS compatible input reference to GND that sets the state of PD and PU pins. INP has an internal pull-down to GND to keep PD pulled to SRC when INP is left floating.



表 5-1. Pin Functions (续)

PIN			TYPE	DESCRIPTION
NAME	TPS48110-Q1	TPS48111-Q1		
	DGX-19 (VSSOP)			
FLT_T	4	4	O	Open Drain Fault Output. This pin asserts low when overtemperature fault is detected.
FLT_I	5	5	O	Open Drain Fault Output. This pin asserts low after the voltage on the TMR pin has reached the fault threshold of 1.1 V. This pin indicates the pass transistor is about to turn off due to an overcurrent condition. The FLT_I pin does not go to a high-impedance state until the overcurrent condition and the auto-retry time expire.
GND	6	6	G	Connect GND to system ground.
IMON	7	7	O	Analog current monitor output. This pin sources a scaled down ratio of current through the external current sense resistor R <sub>SNS</sub> . A resistor from this pin to GND converts current proportional to voltage. If unused, connect the pin to GND.
IWRN	8	8	I	Overcurrent detection setting. A resistor across IWRN to GND sets the over current comparator threshold. Connect IWRN to GND if overcurrent protection feature is not desired.
TMR	9	9	I	Fault Timer Input. A capacitor across TMR pin to GND sets the time for fault warning, fault turn-off (FLT_I) and retry periods. Leave it open for fastest setting. Connect TMR to GND to disable overcurrent protection.
DIODE	10	10	I	Diode connection for temperature sensing. Connect this pin to base and collector of an MMBT3904 NPN BJT. Connect DIODE to GND, if remote overtemperature protection feature is not desired.
G	—	11	O	GATE of external pre-charge FET. Connect to the GATE of the external FET. Leave the G pin floating if the G drive functionality is unused.
N.C	11	—	—	No connect.
BST	12	12	O	High Side Bootstrapped Supply. An external capacitor with a minimum value of > Q <sub>g(tot)</sub> of the external FET must be connected between this pin and SRC.
SRC	13	13	O	Source connection of the external FET.
PD	14	14	O	High Current Gate Driver Pull-Down. This pin pulls down to SRC. For the fastest turn-off, tie this pin directly to the gate of the external high side MOSFET.
PU	15	15	O	High Current Gate Driver Pull-Up. This pin pulls up to BST. Connect this pin to PD for maximum gate drive transition speed. A resistor can be connected between this pin and the gate of the external MOSFET to control the in-rush current during turn-on.
CS-	17	17	I	Current sense negative input.
CS+	18	18	I	Current sense positive input. Connect a 50 - 100-Ω resistor across CS+ to the external current sense resistor.
ISCP	19	19	I	Short-circuit detection threshold setting. Connect ISCP to CS - if short-circuit protection is not desired.
VS	20	20	Power	Supply pin of the controller.



## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
Input Pins	VS, CS+, CS - , ISCP to GND	- 1	100	V
	VS, CS+, CS - to SRC	- 60	100	
	SRC to GND	- 30	100	
	PU, PD, G, BST to SRC	- 0.3	16	
	TMR, IWRN, DIODE to GND	- 0.3	5.5	
	OV, EN/UVLO, INP, INP_G, FLT_I , FLT_T to GND	- 1	20	
	CS+ to CS -	- 0.3	0.3	
	I(FLT_I), I(FLT_T)		10	mA
	I(CS+) to I(CS - ) , 1msec	- 100	100	
Output Pins	PU, PD, G, BST to GND	- 30	112	V
	IMON to GND	- 1	7.5	
Operating junction temperature, T <sub>j</sub> <sup>(2)</sup>		- 40	150	°C
Storage temperature, T <sub>stg</sub>		- 40	150	

- (1) Stresses beyond those listed under *Absolute Maximum Rating* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Condition*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) High junction temperatures degrade operating lifetimes. Operating lifetime is de-rated for junction temperatures greater than 125°C.

### 6.2 ESD Ratings

				VALUE	UNIT
V <sub>(ESD)</sub>	Electrostatic discharge	Human body model (HBM), per AEC Q100-002 <sup>(1)</sup>		±2000	V
		Charged device model (CDM), per AEC Q100-011	Corner pins (EN/UVLO, DIODE, G, VS)	±750	
			Other pins	±500	

- (1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	NOM	MAX	UNIT
Input Pins	VS, CS+, CS - to GND	0		80	V
	EN/UVLO, OV to GND	0		15	
Output Pins	FLT_I, FLT_T to GND	0		15	
	IMON to GND	0		5	
External Capacitor	VS to GND	22			nF
	BST to SRC	0.1			μF
T <sub>j</sub>	Operating Junction temperature <sup>(2)</sup>	- 40		150	°C

- (1) Recommended Operating Conditions are conditions under which the device is intended to be functional. For specifications and test conditions, see Electrical Characteristics.
- (2) High junction temperatures degrade operating lifetimes. Operating lifetime is de-rated for junction temperatures greater than 125°C.



## 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		TPS4811x-Q1	UNIT
		DGX	
		19 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	87	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	26.5	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	43.7	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	0.5	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	43.3	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 6.5 Electrical Characteristics

$T_J = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ ; typical values at  $T_J = 25^{\circ}\text{C}$ ,  $V_{(VS)} = V_{(CS+)} = V_{(CS-)} = 48\text{ V}$ ,  $V_{(BST - SRC)} = 12\text{ V}$ ,  $V_{(SRC)} = 0\text{ V}$ ,  $V_{SNS} =$  Voltage across  $R_{SNS}$

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY VOLTAGE						
V <sub>(VS)</sub>	Operating input voltage		3.5		80	V
V <sub>(VS_PORR)</sub>	VS POR threshold, rising		2.75	3	3.2	V
V <sub>(VS_PORF)</sub>	VS POR threshold, falling		2.65	2.9	3.1	V
I <sub>(Q)</sub>	Total System Quiescent current, I <sub>(GND)</sub>	V <sub>(EN/UVLO)</sub> = 2 V		613	700	μA
I <sub>(SHDN)</sub>	SHDN current, I <sub>(GND)</sub>	V <sub>(EN/UVLO)</sub> = 0 V, V <sub>(SRC)</sub> = 0 V		1.6	5.36	μA
		V <sub>(EN/UVLO)</sub> = 0 V, V <sub>(SRC)</sub> = 0 V, - 40°C < T <sub>j</sub> < 85°C		1.6	2.65	μA
ENABLE AND UNDERVOLTAGE LOCKOUT (EN/UVLO) INPUT						
V <sub>(UVLOR)</sub>	UVLO threshold voltage, rising		1.16	1.18	1.2	V
V <sub>(UVLOF)</sub>	UVLO threshold voltage, falling		1.1	1.11	1.13	V
V <sub>(ENF)</sub>	Enable threshold voltage for low IQ shutdown, falling		0.3	0.7	0.9	V
	Enable Hysteresis			43	60	mV
I <sub>(EN/UVLO)</sub>	Enable input leakage current	V <sub>(EN/UVLO)</sub> = 12 V		61	320	nA
OVER VOLTAGE PROTECTION (OV) INPUT - TPS48110-Q1 Only						
V <sub>(OVR)</sub>	Overvoltage threshold input, rising	TPS48110-Q1 Only	1.16	1.18	1.2	V
V <sub>(OVF)</sub>	Overvoltage threshold input, falling		1.1	1.11	1.13	V
I <sub>(OV)</sub>	OV Input leakage current	0 V < V <sub>(OV)</sub> < 5 V		60	300	nA
CHARGE PUMP (BST - SRC)						
I <sub>(BST)</sub>	Charge Pump Supply current	V <sub>(BST - SRC)</sub> = 10 V	80	100	126	μA
V <sub>(BST - SRC)</sub>	Charge Pump Turn ON voltage		11	11.7	12.3	V
	Charge Pump Turn OFF voltage		11.6	12.3	13	V
V <sub>(BST_UVLOR)</sub>	V <sub>(BST - SRC)</sub> UVLO voltage threshold, rising		7	7.6	8.1	V
V <sub>(BST_UVLOF)</sub>	V <sub>(BST - SRC)</sub> UVLO voltage threshold, falling		6	6.5	6.9	V
V <sub>(BST - SRC)</sub>	Charge Pump Voltage at V <sub>(VS)</sub> = 3.5 V		8.6			V
GATE DRIVER OUTPUTS (PU, PD, G)						
R <sub>(PD)</sub>	Pull-Down Resistance			0.69	1.34	Ω
I <sub>(PU)</sub>	Peak Source Current			3.75		A



## 6.5 Electrical Characteristics (续)

$T_J = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ ; typical values at  $T_J = 25^{\circ}\text{C}$ ,  $V_{(VS)} = V_{(CS+)} = V_{(CS-)} = 48\text{ V}$ ,  $V_{(BST - SRC)} = 12\text{ V}$ ,  $V_{(SRC)} = 0\text{ V}$ ,  $V_{SNS} =$  Voltage across  $R_{SNS}$

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I <sub>(PD)</sub>	Peak Sink Current		4			A
I <sub>(G)</sub>	Gate charge (sourcing) current, on state	TPS48111-Q1 Only	72	100	140	μA
	Gate discharge (sinking) current, off state		92	131	190	mA
CURRENT SENSE AND OVER CURRENT PROTECTION (CS+, CS -, IMON, ISCP, IWRN)						
V <sub>(OS_SET)</sub>	Input referred offset (V <sub>SNS</sub> to V <sub>(IMON)</sub> scaling)	R <sub>SET</sub> = 100 Ω, R <sub>IMON</sub> = 5 kΩ, 10 kΩ (corresponds to V <sub>SNS</sub> = 6 mV to 30 mV) Gain of 45 and 90 respectively.	- 200		200	μV
V <sub>(GE_SET)</sub>	Gain error (V <sub>SNS</sub> to V <sub>(IMON)</sub> scaling)		- 1.27		1.27	%
V <sub>(IMON_Acc)</sub>	IMON accuracy	V <sub>SNS</sub> = 30 mV, R <sub>SET</sub> = 100 Ω, R <sub>IMON</sub> = 10 kΩ	- 2		2	%
		V <sub>SNS</sub> = 6 mV, R <sub>SET</sub> = 100 Ω, R <sub>IMON</sub> = 5 kΩ	- 5		5	%
V <sub>(SNS_WRN)</sub>	Overcurrent protection (OCP) voltage threshold	R <sub>SET</sub> = 100 Ω, R <sub>IWRN</sub> = 39.7 kΩ	29.2	30.6	31.5	mV
		R <sub>SET</sub> = 100 Ω, R <sub>IWRN</sub> = 120 kΩ	8	10	12	mV
I <sub>(ISCP)</sub>	SCP Input Bias current		13.7	15.6	17.6	μA
V <sub>(SNS_SCP)</sub>	Short-circuit protection (SCP) voltage threshold	R <sub>ISCP</sub> = 2.1 kΩ	35	40	45	mV
		R <sub>ISCP</sub> = 750 Ω		19		mV
DELAY TIMER (TMR)						
I <sub>(TMR_SRC_CB)</sub>	TMR source current		73	82	91	μA
I <sub>(TMR_SRC_FLT)</sub>	TMR source current		2.1	2.5	3.3	μA
I <sub>(TMR_SNK)</sub>	TMR sink current		2.1	2.5	3	μA
V <sub>(TMR_OC)</sub>	TMR voltage threshold for over current shutdown		1.112	1.2	1.3	V
V <sub>(TMR_FLT)</sub>	TMR voltage threshold for FLT_T assertion		1.03	1.1	1.2	V
V <sub>(TMR_LOW)</sub>	Voltage at TMR pin for AR counter falling threshold		0.15	0.2	0.22	V
INPUT CONTROLS (INP, INP_G), FAULT FLAGS (FLT_I, FLT_T)						
R <sub>(FLT_I)</sub>	FLT_I Pull-down resistance		54	70	90	Ω
R <sub>(FLT_T)</sub>	FLT_T Pull-down resistance			70		Ω
I <sub>(FLT_T)</sub>	FLT Input leakage current				400	nA
V <sub>(INP_H)</sub>				1.6	2	V
V <sub>(INP_L)</sub>			0.8	1.2		V
V <sub>(INP_Hys)</sub>				400		mV
V <sub>(INP_G_H)</sub>		TPS48111 - Q1 Only		1.6	2	V
V <sub>(INP_G_L)</sub>			0.8	1.2		V
V <sub>(INP_G_Hys)</sub>				400		mV
TEMPERATURE SENSING AND PROTECTION (DIODE)						
I <sub>(DIODE)</sub>	External diode current source	High level		160		μA
		Low level		10		μA
	Diode current ratio		15.4	16	16.6	A/A
T <sub>(DIODE_TSD_rising)</sub>	DIODE sense TSD rising threshold	With MMBT3904 BJT for sensing	140	150	160	°C



## 6.6 Switching Characteristics

$T_J = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ ; typical values at  $T_J = 25^{\circ}\text{C}$ ,  $V_{(VS)} = V_{(CS+)} = V_{(CS-)} = 48\text{ V}$ ,  $V_{(BST - SRC)} = 12\text{ V}$ ,  $V_{(SRC)} = 0\text{ V}$ ,  $V_{SNS} =$  Voltage across  $R_{SNS}$

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{PU(INP\_H)}$	INP Turn ON propagation Delay	INP $\uparrow$ to PU $\uparrow$ , $C_L = 47\text{ nF}$		1	2	$\mu\text{s}$
$t_{PD(INP\_L)}$	INP Turn OFF propagation Delay	INP $\downarrow$ to PD $\downarrow$ , $C_L = 47\text{ nF}$			1	$\mu\text{s}$
$t_{G(INP\_G\_H)}$	INP_G Turn ON propagation Delay	INP_G $\uparrow$ to G $\uparrow$ , $C_L = 1\text{ nF}$		21		$\mu\text{s}$
$t_{G(INP\_G\_L)}$	INP_G Turn OFF propagation Delay	INP_G $\downarrow$ to G $\downarrow$ , $C_L = 1\text{ nF}$		0.55	0.8	$\mu\text{s}$
$t_{PD(EN\_OFF)}$	EN Turn OFF Propagation Delay	EN $\downarrow$ to PD $\downarrow$ , $C_L = 47\text{ nF}$		3.2	5	$\mu\text{s}$
$t_{PD(UVLO\_OFF)}$	UVLO Turn OFF Propagation Delay	UVLO $\downarrow$ to PD $\downarrow$ , $C_L = 47\text{ nF}$		3.5	6	$\mu\text{s}$
$t_{PD(VS\_OFF)}$	PD Turn OFF delay during input supply (VS) interruption	VS $\downarrow$ $V_{(VS\_PORF)}$ to PD $\downarrow$ , $C_L = 47\text{ nF}$ , INP = EN/UVLO = 2 V		54		$\mu\text{s}$
$t_{PU(VS\_ON)}$	PU Turn ON delay during input supply (VS) recovery	VS $\uparrow$ $V_{(VS\_PORR)}$ to PU $\uparrow$ , $C_L = 47\text{ nF}$ , INP = EN/UVLO = 2 V, $V_{(BST - SRC)} > V_{(BST\_UVLOR)}$		328	465	$\mu\text{s}$
$t_{PD(OV\_OFF)}$	OV Turn Off propagation Delay	OV $\uparrow$ to PD $\downarrow$ , $C_L = 47\text{ nF}$		2.6	4	$\mu\text{s}$
$t_{SC}$	Short-circuit protection propagation Delay	$(V_{CS+} - V_{CS-}) \uparrow V_{(SNS\_SCP)}$ to PD $\downarrow$ , $C_L = 47\text{ nF}$ , TPS48111-Q1 Only		1.16	1.6	$\mu\text{s}$
	Short-circuit protection propagation Delay	$(V_{CS+} - V_{CS-}) \uparrow V_{(SNS\_SCP)}$ to PD $\downarrow$ , $C_L = 47\text{ nF}$ , TPS48110 - Q1 Only		4	5	$\mu\text{s}$
$t_{OC}$	Over current protection delay	$(V_{CS+} - V_{CS-}) \uparrow V_{(SNS\_WRN)}$ to PD $\downarrow$ , $C_L = 47\text{ nF}$ , $C_{TMR} = 0\text{ nF}$		25	30	$\mu\text{s}$
	Over current protection delay	$(V_{CS+} - V_{CS-}) \uparrow V_{(SNS\_WRN)}$ to PD $\downarrow$ , $C_L = 47\text{ nF}$ , $C_{TMR} = 22\text{ nF}$		370		$\mu\text{s}$
$t_{(FLT\_I\_ASSERT)}$	FLT_I assertion delay	$C_{TMR} = 22\text{ nF}$		340		$\mu\text{s}$
$t_{(FLT\_I\_DEASSERT)}$	FLT_I de-assertion delay			260		$\mu\text{s}$
$t_{(FLT\_T)AR}$	TSD Auto-retry	TPS48110-Q1 Only		512		msec



## 6.7 Typical Characteristics

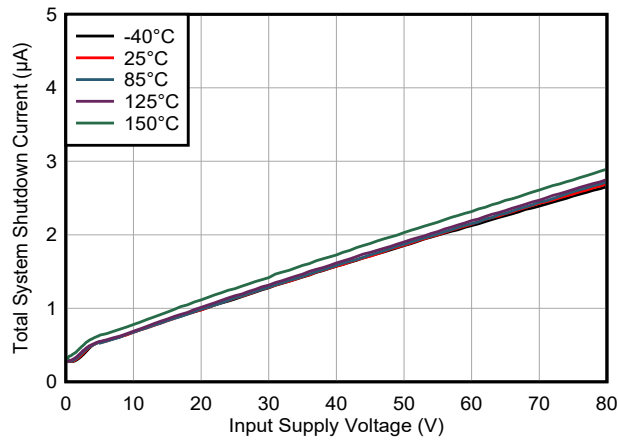


图 6-1. Shutdown Supply Current vs Supply Voltage

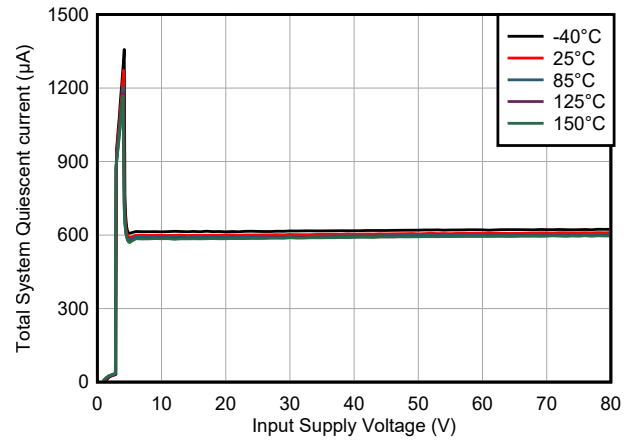


图 6-2. Operating Quiescent Current vs Supply Voltage

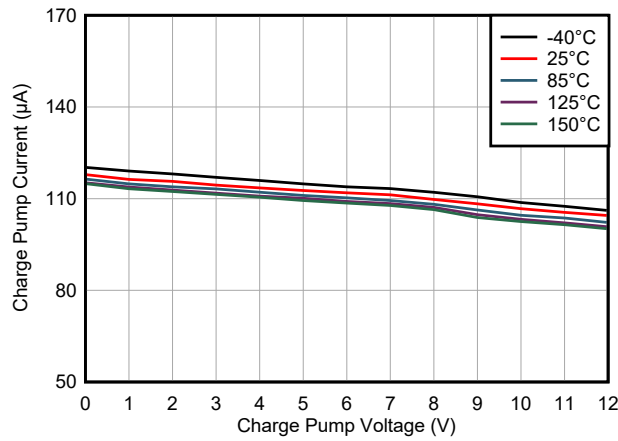


图 6-3. Charge Pump Current vs Charge Pump Voltage

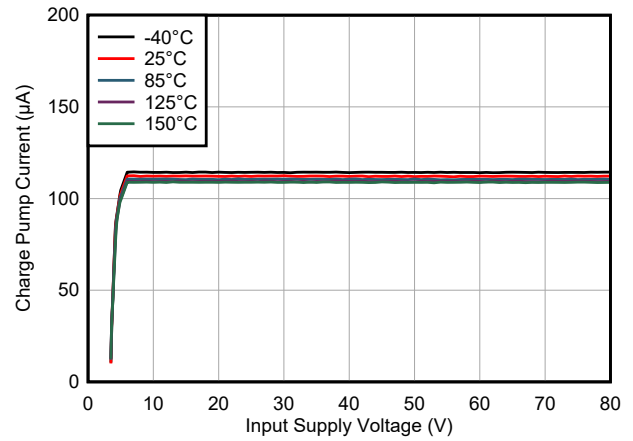


图 6-4. Charge Pump Current vs Input Supply Voltage

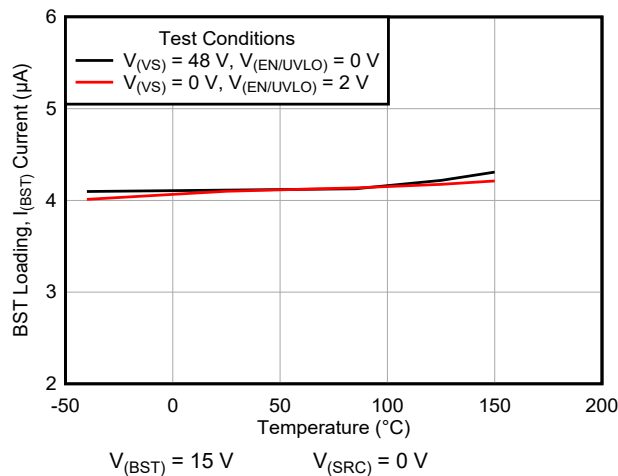


图 6-5. BST Loading Current ( $I_{BST}$ ) vs Temperature

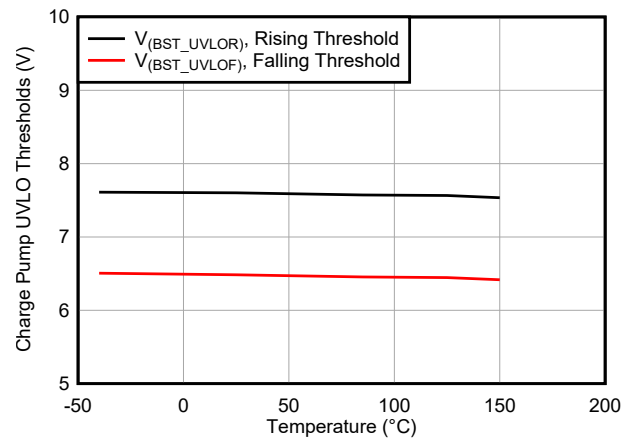


图 6-6. Charge Pump UVLO Thresholds vs Temperature



## 6.7 Typical Characteristics (continued)

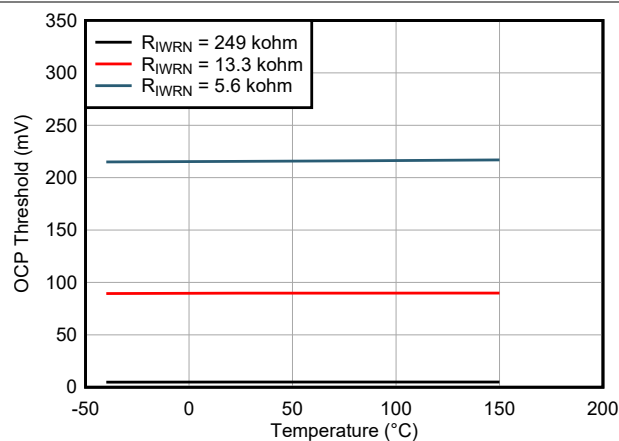
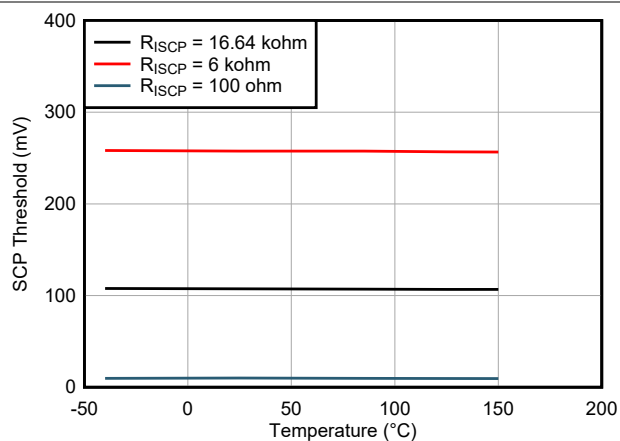
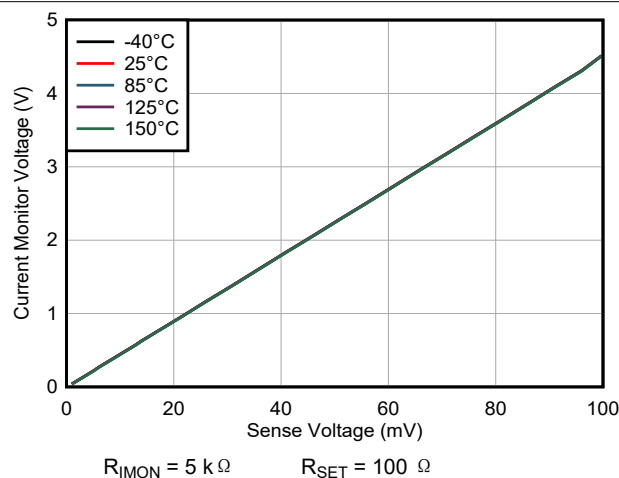
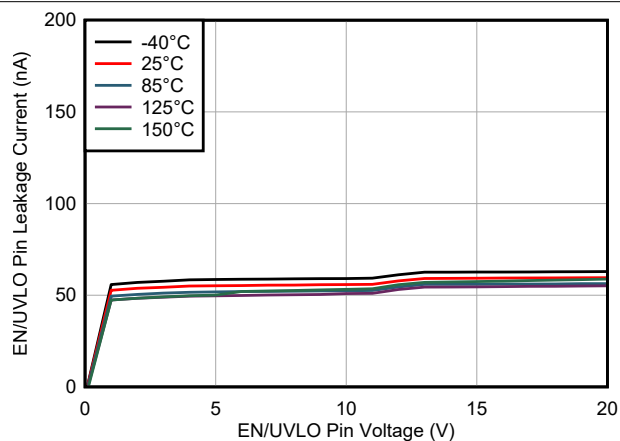
图 6-7. Overcurrent Threshold ( $V_{SNS\_WRN}$ ) vs Temperature图 6-8. Short-Circuit Threshold ( $V_{SNS\_SCP}$ ) vs Temperature图 6-9. Current Monitor Output ( $V_{IMON}$ ) vs Sense Voltage ( $V_{SNS}$ )

图 6-10. EN/UVLO Pin Voltage vs Current

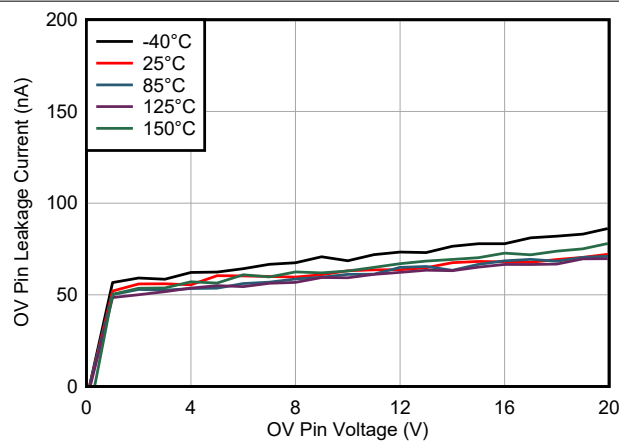
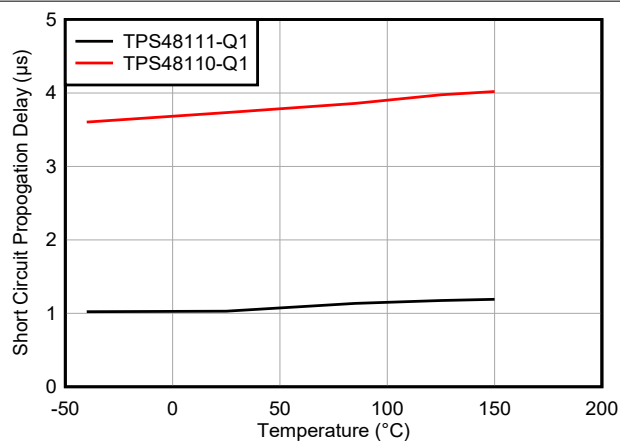


图 6-11. OV Pin Voltage vs Leakage Current

图 6-12. Short-Circuit Protection Response Time ( $t_{SC}$ ) vs Temperature



## 6.7 Typical Characteristics (continued)

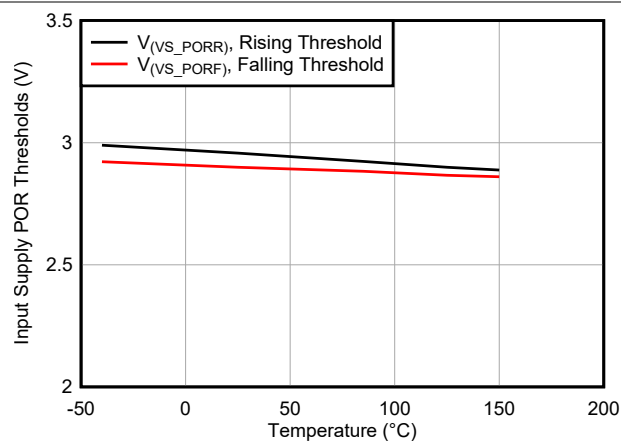


图 6-13. Input Supply POR Thresholds vs Temperature

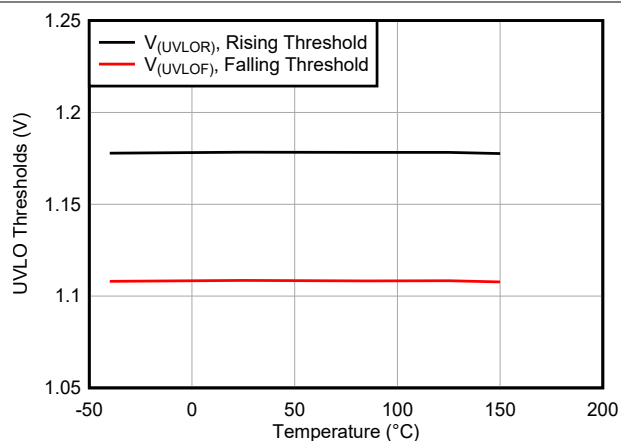


图 6-14. Input Supply UVLO Thresholds vs Temperature

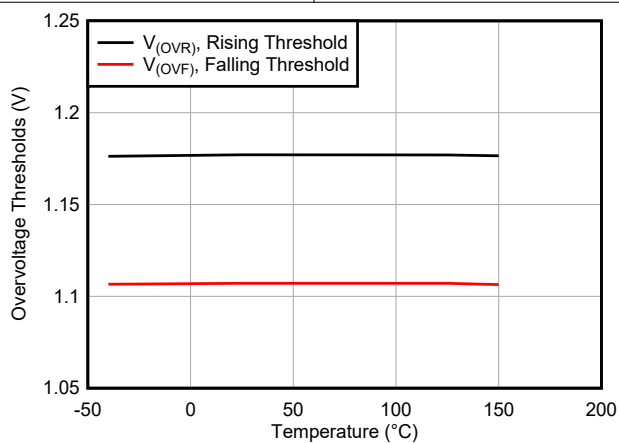


图 6-15. Overvoltage Thresholds vs Temperature



## 7 Parameter Measurement Information

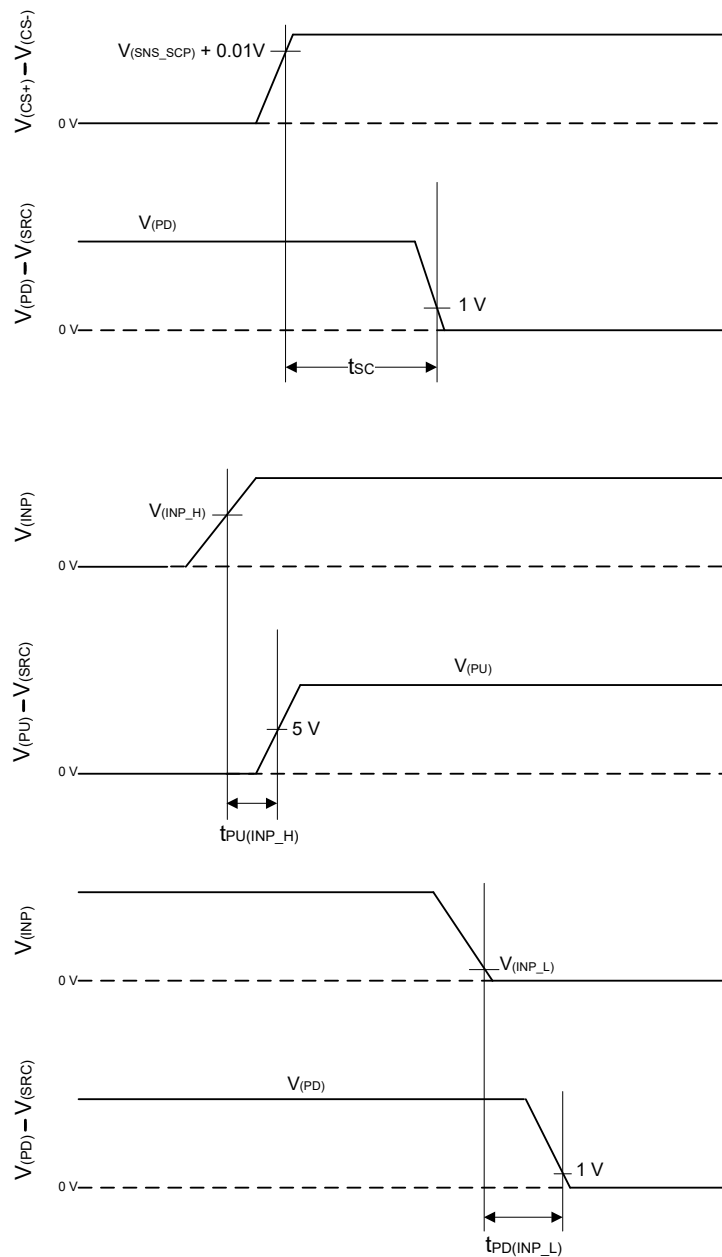


图 7-1. Timing Waveforms



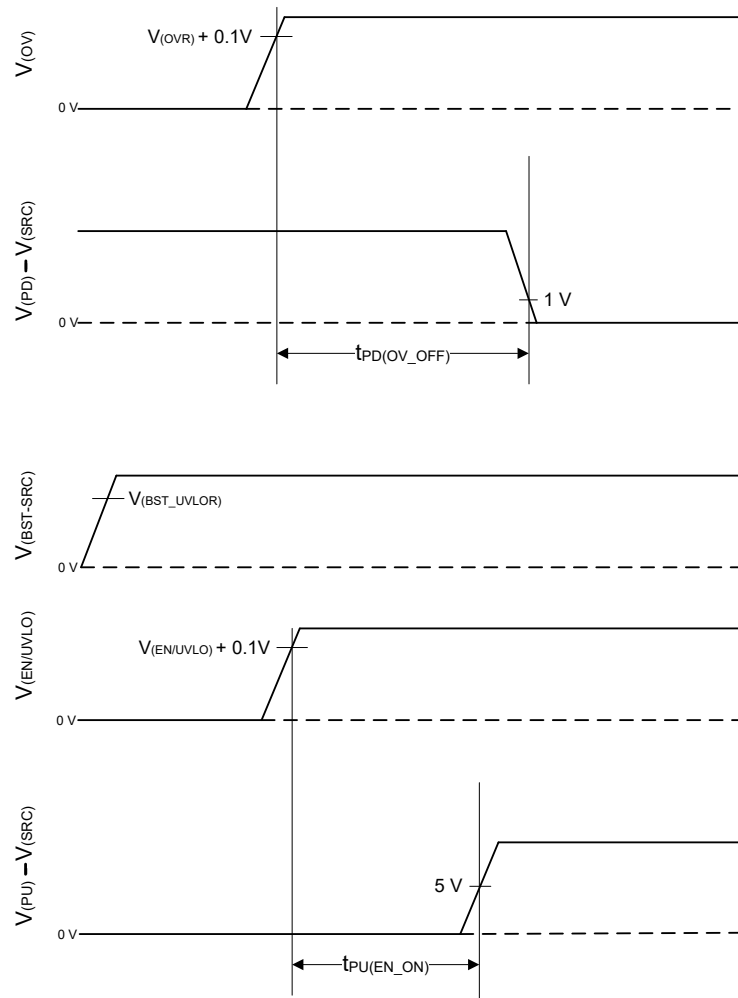


图 7-2. Timing Waveforms



## 8 Detailed Description

### 8.1 Overview

The TPS4811x-Q1 family is a 100-V smart high side driver with protection and diagnostics. With wide operating voltage range of 3.5 V – 80 V, the device is suitable for 12-V, 24-V, and 48-V system designs.

The device has a strong 3.7-A peak source (PU) and 4-A peak sink (PD) GATE driver that enables power switching using parallel FETs in high current system designs. Use INP as the gate driver control input. MOSFET slew rate control (ON and OFF) is possible by placing external R-C components.

The device has accurate current sensing ( $\pm 2\%$  at 30-mV  $V_{SNS}$ ) output (IMON) enabling systems for energy management. The device has integrated two-level overcurrent protection with  $\overline{\text{FLT\_I}}$  output with complete adjustability of thresholds and response time. Auto-retry and latch-off fault behavior can be configured.

The device features remote overtemperature protection with  $\overline{\text{FLT\_T}}$  output enabling robust system protection.

TPS48110-Q1 has an accurate overvoltage protection ( $< \pm 2\%$ ), providing robust load protection.

The TPS48111-Q1 integrates a pre-charge driver (G) with control input (INP\_G). This feature enables system designs that need to drive large capacitive loads by pre-charging first and then turning ON the main power FETs.

TPS4811x-Q1 has an accurate undervoltage protection ( $< \pm 2\%$ ) using EN/UVLO pin. Pull EN/UVLO low ( $< 0.3$  V) to turn OFF the device and enter into shutdown state. In shutdown mode, the controller draws a total shutdown current of 1.6  $\mu\text{A}$  at 48-V supply input.

### 8.2 Functional Block Diagram

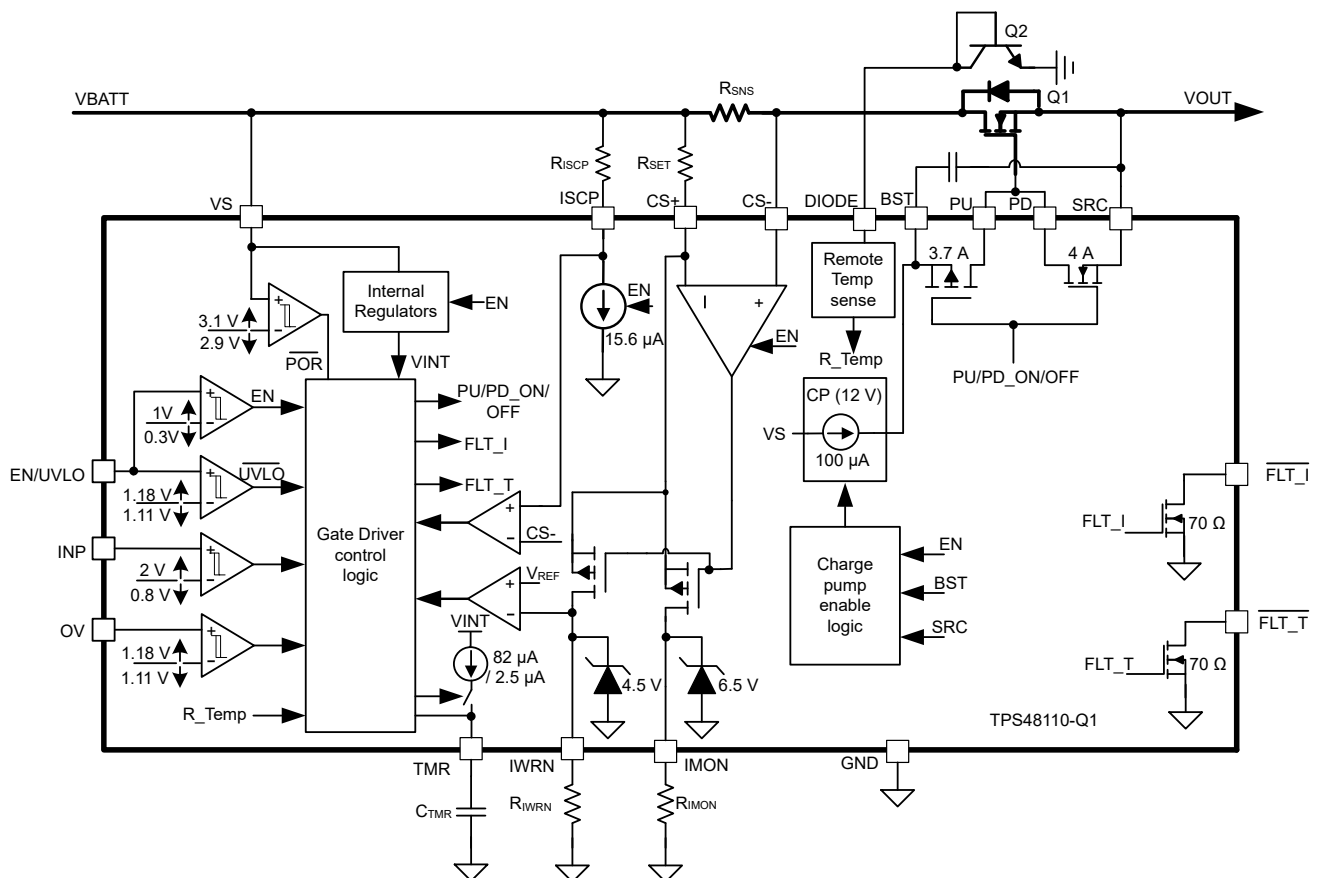


图 8-1. TPS48110-Q1 Functional Block Diagram



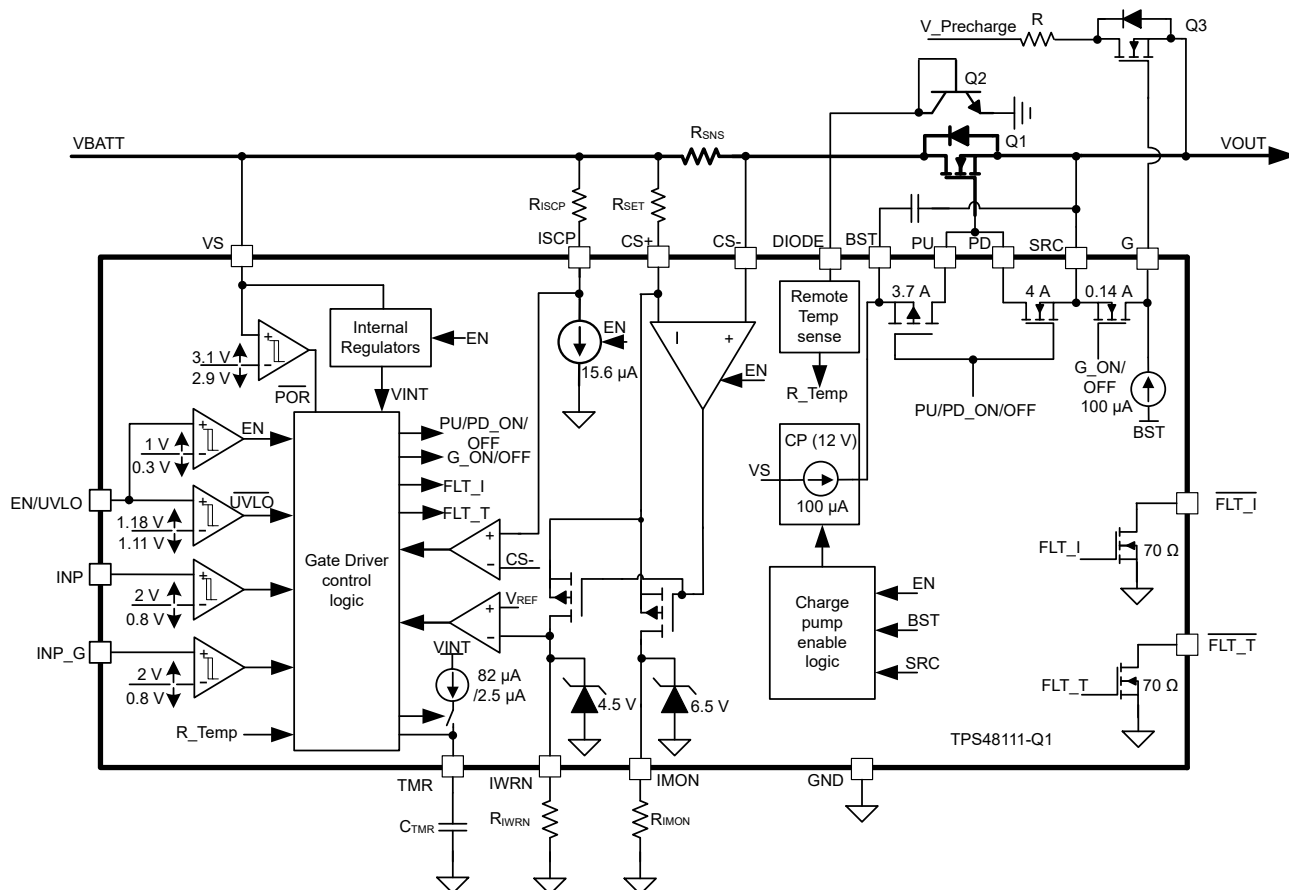


图 8-2. TPS4811-Q1 Functional Block Diagram

## 8.3 Feature Description

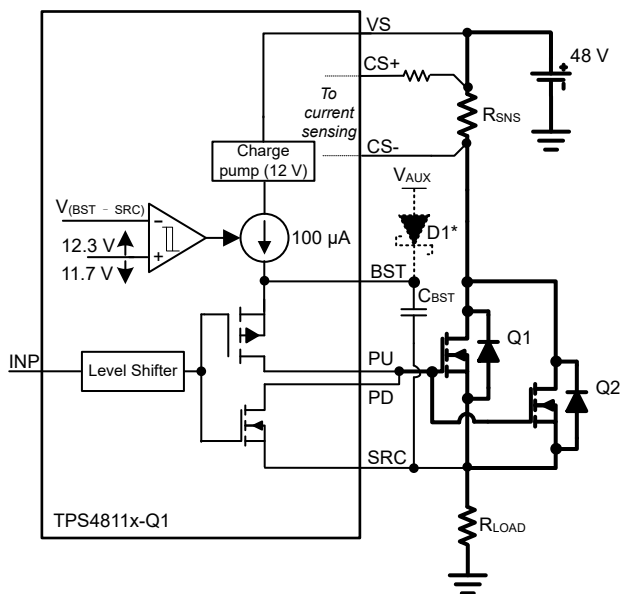
### 8.3.1 Charge Pump and Gate Driver output (VS, PU, PD, BST, SRC)

图 8-3 shows simplified diagram of the charge pump and gate driver circuit implementation. The device houses a strong 3.7-A peak source and 4-A peak sink gate drivers. The strong gate drivers enable paralleling of FETs in high power system designs ensuring minimum transition time in saturation region. A 12-V, 100- $\mu$ A charge pump is derived from VS terminal and charges the external boot-strap capacitor,  $C_{BST}$  that is placed across the GATE driver (BST and SRC).

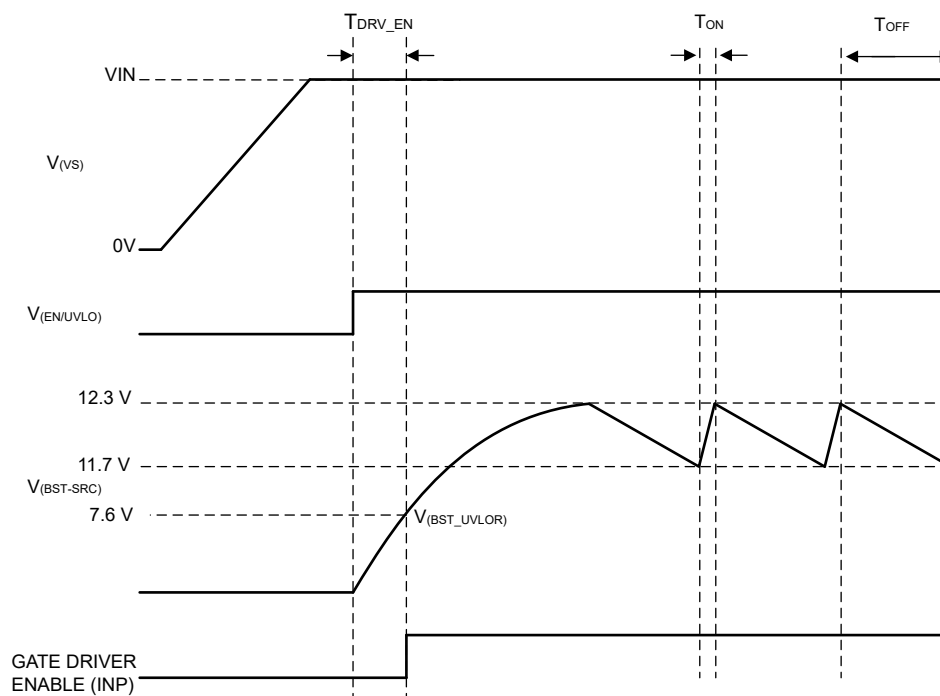
In switching applications, if the charge pump supply demand is higher than 100  $\mu$ A, then supply BST externally using a low leakage diode and  $V_{AUX}$  supply as shown in the 图 8-3.

VS is the supply pin to the controller. With VS applied and EN/UVLO pulled high, the charge pump turns ON and charges the  $C_{BST}$  capacitor. After the voltage across  $C_{BST}$  crosses  $V_{(BST\_UVLO)}$ , the GATE driver section gets activated. The device has a 1-V (typical) UVLO hysteresis to ensure chattering less performance during initial GATE turn ON. Choose  $C_{BST}$  based on the external FET's  $Q_G$  and allowed dip during FET turn ON. The charge pump remains enabled until the BST to SRC voltage reaches 12.3 V, typically, at which point the charge pump is disabled decreasing the current draw on the VS pin. The charge pump remains disabled until the BST to SRC voltage discharges to 11.7 V typically at which point the charge pump is enabled. The voltage between BST and SRC continue to charge and discharge between 12.3 V and 11.7 V as shown in the 图 8-3.





**图 8-3. Gate Driver**



**图 8-4. Charge Pump Operation**

Use the following equation to calculate the initial gate driver enable delay.

$$T_{DRV\_EN} = \frac{C_{BST} \times V_{(BST\_UVLOR)}}{100 \mu A} \quad (1)$$

Where,

$C_{BST}$  is the charge pump capacitance connected across BST and SRC pins,



**图 8-5. TPS48111-Q1 Application Circuit with external supply to BST**

备注

V<sub>AUX</sub> can be supplied by external supply ranging between 8.1 V and 15 V.

Certain end equipments like automotive power distribution unit power different loads including other ECUs. These ECUs can have large input capacitances. If power to the ECUs is switched on in uncontrolled way, large inrush currents can occur potentially damaging the power FETs.

### 8.3.2.1 FET Gate Slew Rate Control

For limiting inrush current during turn ON of the FET with capacitive loads, use  $R_1$ ,  $R_2$ ,  $C_1$  as shown in [图 8-6](#). The  $R_1$  and  $C_1$  components slow down the voltage ramp rate at the gate of the FET. The FET source follows the gate voltage resulting in a controlled voltage ramp across the output capacitors.



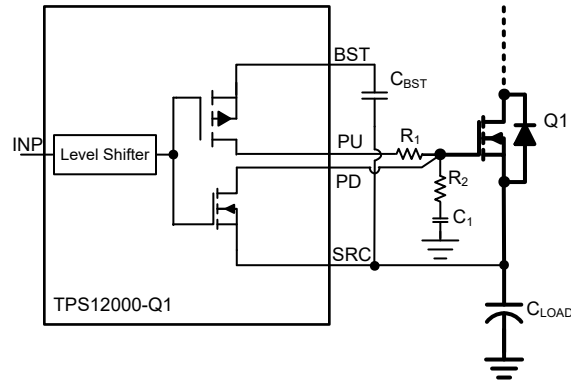


图 8-6. Inrush Current limiting

Use the 方程式 2 to calculate the inrush current during turn-ON of the FET.

$$I_{\text{INRUSH}} = C_{\text{LOAD}} \times \frac{V_{\text{BATT}}}{T_{\text{charge}}} \quad (2)$$

$$I_{\text{INRUSH}} = \frac{0.63 \times V_{(\text{BST-SRC})} \times C_{\text{LOAD}}}{R_1 \times C_1} \quad (3)$$

Where,

$C_{\text{LOAD}}$  is the load capacitance,  $V_{\text{BATT}}$  is the input voltage and  $T_{\text{charge}}$  is the charge time,  $V_{(\text{BST-SRC})}$  is the charge pump voltage (11 V),

Use a damping resistor  $R_2$  ( $\sim 10 \Omega$ ) in series with  $C_1$ . 方程式 3 can be used to compute required  $C_1$  value for a target inrush current. A 100 k $\Omega$  resistor for  $R_1$  can be a good starting point for calculations.

Connecting PD pin of TPS12000-Q1 directly to the gate of the external FET ensures fast turn OFF without any impact of  $R_1$  and  $C_1$  components.

$C_1$  results in an additional loading on  $C_{\text{BST}}$  to charge during turn ON. Use 方程式 4 to calculate the required  $C_{\text{BST}}$  value.

$$C_{\text{BST}} > Q_{\text{g}(\text{total})} + 10 \times C_1 \quad (4)$$

Where,  $Q_{\text{g}(\text{total})}$  is the total gate charge of the FET.

### 8.3.2.2 Using Precharge FET - (with TPS4811-Q1 Only)

In high-current applications where several FETs are connected in parallel, the gate slew rate control for the main FETs is not recommended due to unequal distribution of inrush currents among the FETs. This action makes FET selection complex and results in over sizing of the FETs.

The TPS4811-Q1 integrates precharge gate driver (G) with a dedicated control input (INP\_G). This feature can be used to drive a separate FET that can be used to precharge the capacitive load. 图 8-7 shows the precharge FET implementation for capacitive load charging using TPS4811-Q1. An external capacitor  $C_g$  reduces the gate turn-ON slew rate and controls the inrush current.



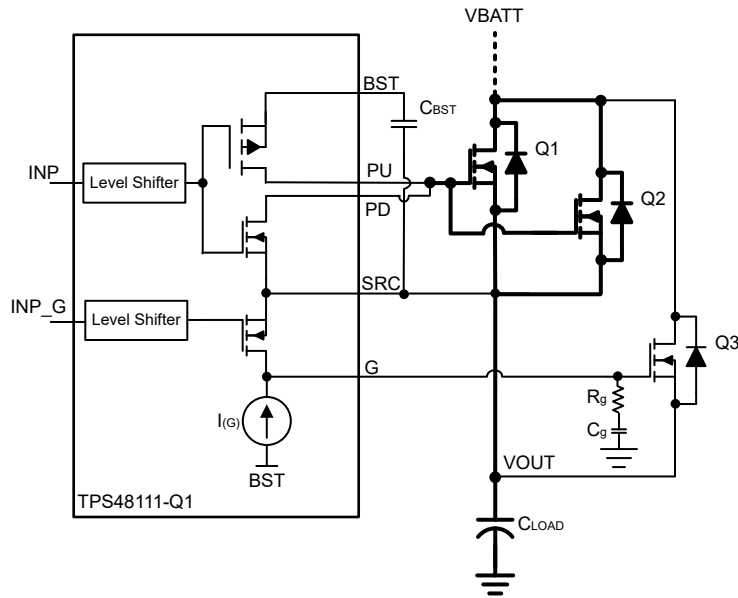


图 8-7. Capacitor Charging Using Gate Slew Rate Control of Precharge FET

During power up with EN/UVLO high and  $C_{BST}$  voltage above  $V_{(BST\_UVLOR)}$  threshold, INP and INP\_G controls are active. For the precharge functionality, drive INP low to keep the main FETs OFF and drive INP\_G high. G output gets pulled up to BST with  $I_G$ . Use 方程式 5 to calculate the required  $C_g$  value.

$$C_g = \frac{C_{LOAD} \times I_{(G)}}{I_{INRUSH}} \quad (5)$$

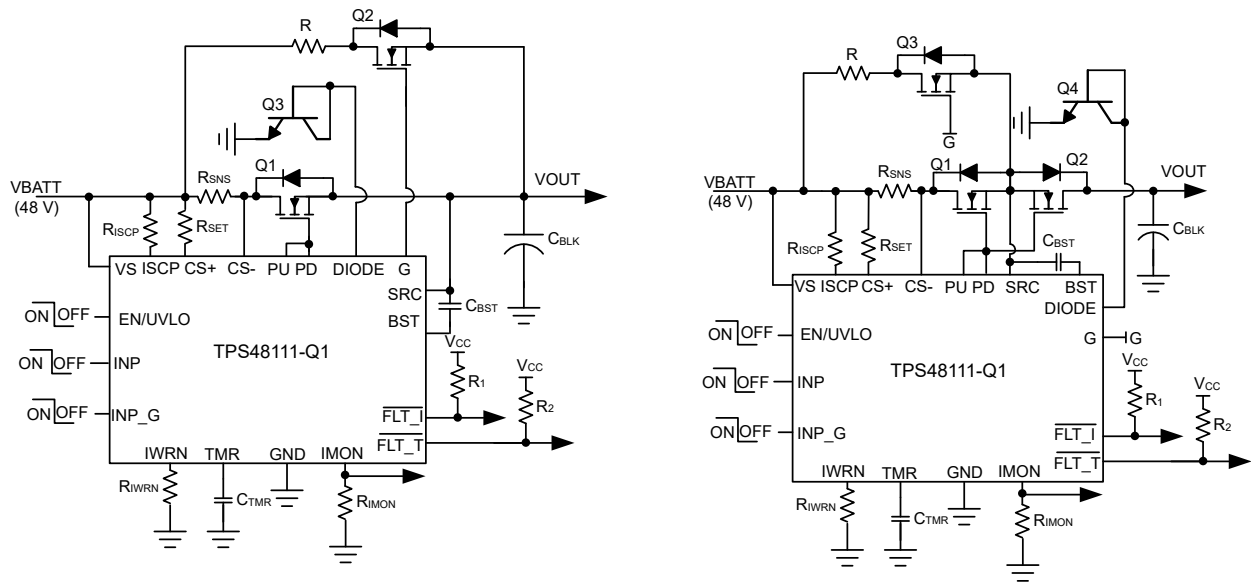
Where,

$I_{(G)}$  is 100  $\mu A$  (typical) and  $C_{LOAD}$  is total load capacitance.

Use 方程式 2 to calculate the  $I_{INRUSH}$ . A series resistor  $R_g$  must be used in conjunction with  $C_g$  to limit the discharge current from  $C_g$  during turn-off. The recommended value for  $R_g$  is between 220  $\Omega$  to 470  $\Omega$ . After the output capacitor is charged, turn OFF the precharge FET by driving INP\_G low. G gets pulled low to SRC with an internal 135-mA pulldown switch. The main FETs can be turned ON by driving INP high.

图 8-8 shows other system design approaches to charge large output capacitors in high current applications. The designs involve an additional power resistor in series in series with precharge FET. The back-to-back FET topology shown is typically used in bi-directional power control applications like battery management systems.





**图 8-8. TPS4811-Q1 application Circuits for Capacitive Load Driving Using Precharge FET and a Series Power Resistor**

### 8.3.3 Short-Circuit Protection

The TPS12000-Q1 feature adjustable short circuit protection. The threshold and the response time can be adjusted using ISCP resistor and TMR capacitor respectively. The device senses the voltage across the CS+ and CS - pins. These pins can be connected across an external current sense resistor or across the FET drain and source terminals for FET RDSON sensing. Set the circuit breaker detection threshold using an external resistor  $R_{ISCP}$  across ISCP and GND. Use 方程式 6 to calculate the required  $R_{ISCP}$  value.

$$R_{ISCP} (\Omega) = \frac{I_{SC} \times R_{SNS} - 10mV}{2 \mu} \quad (6)$$

Where,  $R_{SNS}$  is the current sense resistor value or the FET RDSON value,  $I_{SC}$  is the short circuit current level. The short circuit protection response is fastest  $< 6 \mu s$  with no  $C_{TMR}$  cap connected across TMR and GND pins.

In the configurations of high side current sense with CS\_SEL connected to GND, during Q1 turn ON, first the FET's VGS is sensed by monitoring the voltage across PD to SRC. Once VGS raises above G1\_GOOD threshold to ensure that the external FET gate is enhanced, then the SCP comparator output is monitored. If the sensed voltage across CS+ and CS - exceeds the ISCP set point, PD pulls low to SRC and  $\overline{FLT}$  asserts low within  $6 \mu s$  (with TMR open). Subsequent events can be set either to be auto-retry or latch off as described in following sections

With CS\_SEL connected to  $>2V$  i.e low side current sense configurations, the device does not wait for the FETs to enhance (doesnot wait for G1\_GOOD threshold to reach) and directly looks at the SCP comparator output to pull PD to SRC in the case of a short circuit event.

#### 8.3.3.1 Overcurrent Protection With Auto-Retry

The  $C_{TMR}$  programs the over current protection delay ( $t_{OC}$ ) and auto-retry time ( $t_{RETRY}$ ). Once the voltage across CS+ and CS - exceeds the set point, the  $C_{TMR}$  starts charging with  $80\text{-}\mu A$  pull-up current. After the  $C_{TMR}$  charges up to  $V_{(TMR\_FLT)}$ ,  $\overline{FLT}$  asserts low providing warning on impending FET turn OFF. After  $C_{TMR}$  charges to



$V_{(TMR\_OC)}$ , PD pulls low to SRC turning OFF the FET. Post this event, the auto-retry behavior starts. The  $C_{TMR}$  capacitor starts discharging with 2.5- $\mu$ A pulldown current. After the voltage reaches  $V_{(TMR\_LOW)}$  level, the capacitor starts charging with 2.5- $\mu$ A pullup. After 32 charging-discharging cycles of  $C_{TMR}$  the FET turns ON back and FLT de-asserts

Use 方程式 7 to calculate the  $C_{TMR}$  capacitor to be connected across TMR and GND.

$$C_{TMR} = \frac{I_{TMR} \times t_{OC}}{1.2} \quad (7)$$

Where,  $I_{TMR}$  is internal pull-up current of 80- $\mu$ A,  $t_{OC}$  is desired overcurrent response time.

The fastest  $t_{OC}$  is < 6  $\mu$ s with no  $C_{TMR}$  cap connected.

$$t_{RETRY} = 22.7 \times 10^6 \times C_{TMR}$$

If the overcurrent pulse duration is below  $t_{OC}$  then the FET remains ON and  $C_{TMR}$  gets discharged using internal pull down switch.

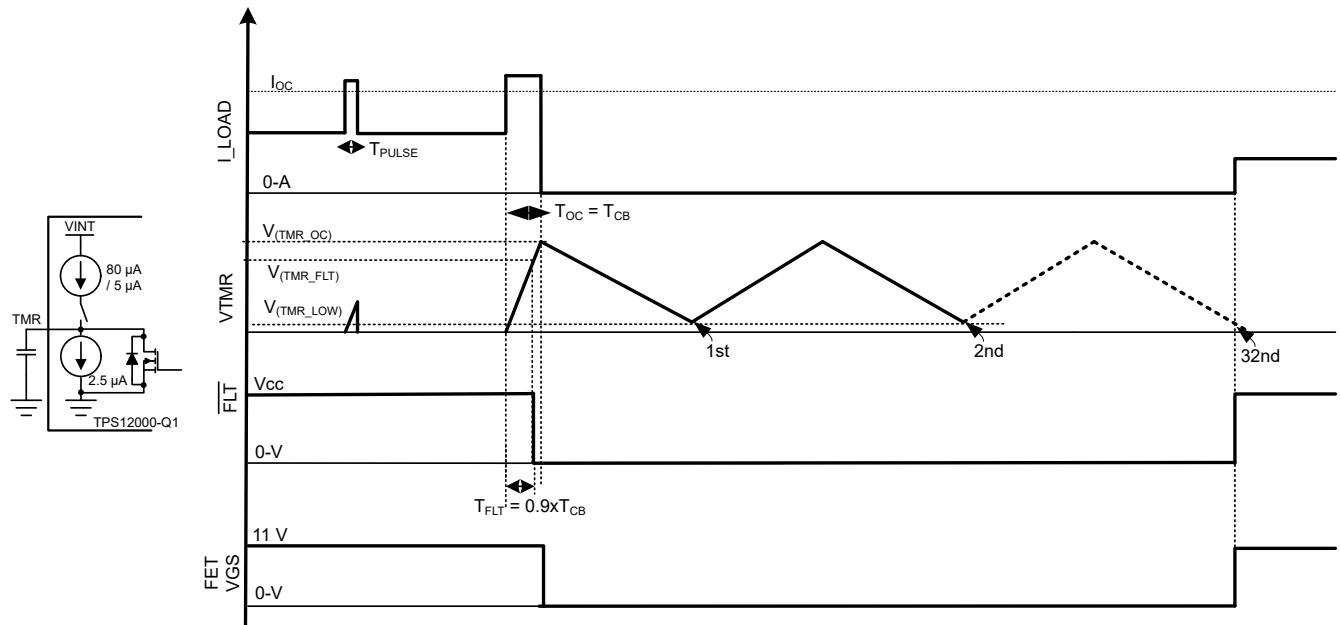


图 8-9. Overcurrent Protection With Auto-Retry

### 8.3.3.2 Overcurrent Protection With Latch-Off

Connect an approximately 100-k $\Omega$  resistor across  $C_{TMR}$  as shown in 图 8-10. With this resistor, during the charging cycle, the voltage across  $C_{TMR}$  gets clamped to a level below  $V_{(TMR\_OC)}$  resulting in a latch-off behavior.

Use 方程式 8 to calculate  $C_{TMR}$  capacitor to be connected between TMR and GND for  $R_{TMR} = 100$ -k $\Omega$ .

$$C_{TMR} = \frac{t_{OC}}{R_{TMR} \times \ln\left(\frac{1}{1 - \frac{1.2}{R_{TMR} \times I_{TMR}}}\right)} \quad (8)$$

Where,  $I_{TMR}$  is internal pull-up current of 80- $\mu$ A,  $t_{OC}$  is desired overcurrent response time.

Toggle INP or EN/UVLO (below  $V_{(ENF)}$ ) or power cycle VS below  $V_{(VS\_PORF)}$  to reset the latch. At low edge, the timer counter is reset and  $C_{TMR}$  is discharged. PU pulls up to BST when INP is pulled high.



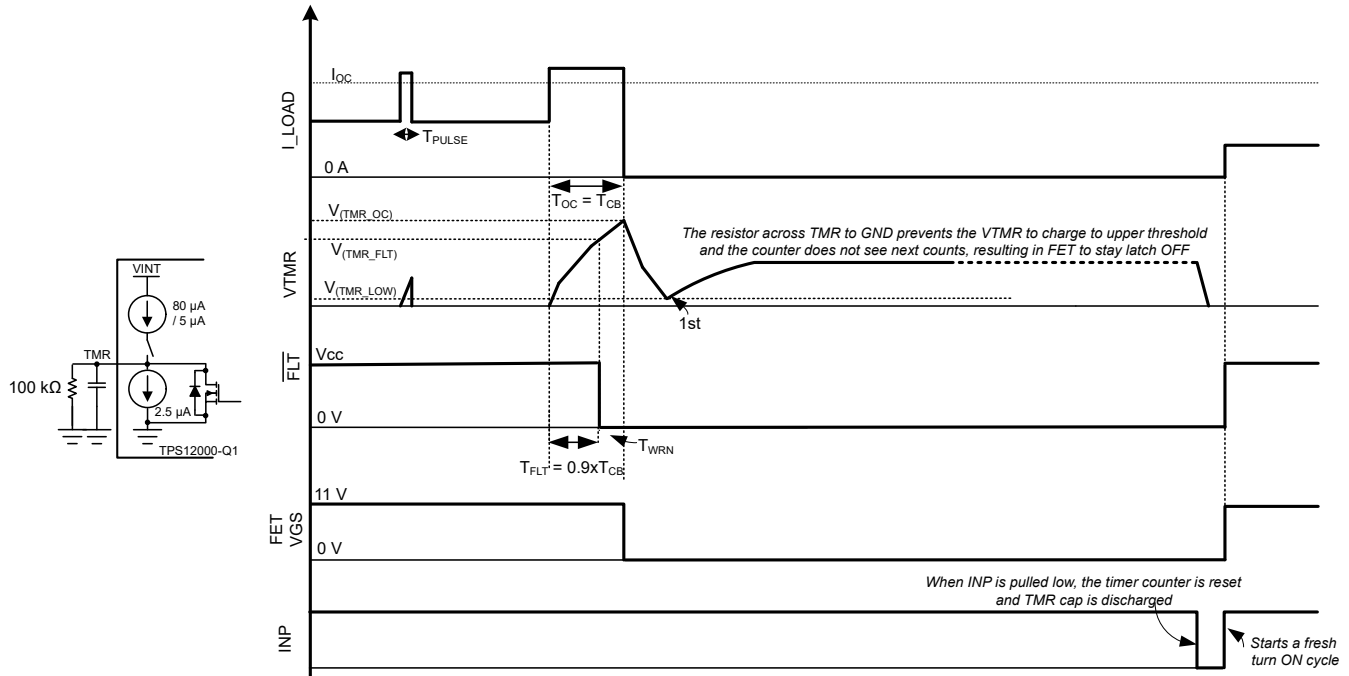


图 8-10. Overcurrent Protection With Latch-Off

### 8.3.4 Short-Circuit Protection

Connect a resistor,  $R_{ISCP}$  as shown in 图 8-11.

Use 方程式 9 to calculate the required  $R_{ISCP}$  value.

$$R_{ISCP} (\Omega) = \frac{I_{SC} \times R_{SNS}}{15.6 \mu} - 600 \quad (9)$$

Where,  $R_{SNS}$  is the current sense resistor, and  $I_{SC}$  is the desired short-circuit protection level. After the current exceeds the  $I_{SC}$  threshold then, PD pulls low to SRC within 1.2  $\mu$ s in TPS4811-Q1 and 4  $\mu$ s in TPS4810-Q1, protecting the FET.  $FLT_I$  asserts low at the same time. Subsequent to this event, the charge and discharge cycles of  $C_{TMR}$  starts similar to the behavior post FET OFF event in the over current protection scheme.

Latch-off can also achieved in the similar way as explained in the overcurrent protection scheme.

#### 备注

Connect IWRN pin to GND if only short-circuit protection is required.  $R_{ISCP}$  resistor can be selected as per 节 8.3.4.

### 8.3.5 Analog Current Monitor Output (IMON)

TPS4811x-Q1 features an accurate analog load current monitor output (IMON) with adjustable gain. The current source at IMON terminal is configured to be proportional to the current flowing through the  $R_{SNS}$  current sense resistor. This current can be converted to a voltage using a resistor  $R_{IMON}$  from IMON terminal to GND terminal. This voltage, computed using 方程式 10, can be used as a means of monitoring current flow through the system.

Use 方程式 10 to calculate the  $V_{(IMON)}$ .

$$V_{(IMON)} = (V_{SNS} + V_{(OS\_SET)}) \times \text{Gain} \quad (10)$$

Where  $V_{SNS} = I_{LOAD} \times R_{SNS}$  and  $V_{(OS\_SET)}$  is the input referred offset ( $\pm 200 \mu$ V) of the current sense amplifier ( $V_{SNS}$  to  $V_{(IMON)}$  scaling). Use the following equation to calculate gain.



$$\text{Gain} = \frac{0.9 \times R_{\text{IMON}}}{R_{\text{SET}}} \quad (11)$$

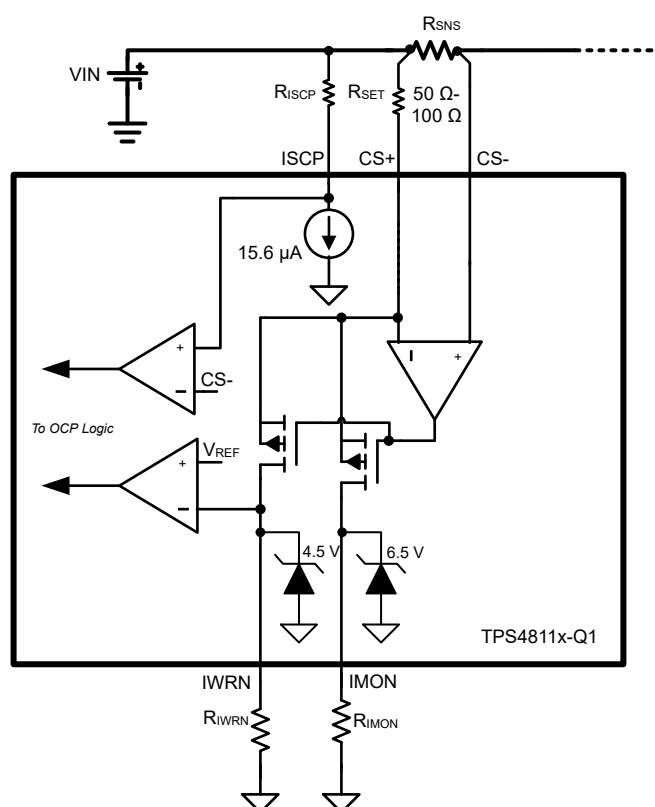
Where 0.9 is the current mirror factor between the current sense amplifier and the IMON pass FET.

The maximum voltage range for monitoring the current ( $V_{(IMONmax)}$ ) is limited to minimum  $[V_{(VS)} - 0.5V]$ , 5.5V) to ensure linear output. This puts limitation on maximum value of  $R_{IMON}$  resistor. The IMON pin has an internal clamp of 6.5 V (typical).

Accuracy of the current mirror factor is  $< \pm 1\%$ . Use the following equation to calculate the overall accuracy of  $V_{(IMON)}$ .

$$\% V_{(\text{IMON})} = \frac{V_{(\text{OS\_SET})}}{V_{\text{SNS}}} \times 100 \quad (12)$$

Figure 8-11 shows external connections and simplified block diagram of current sensing and overcurrent protection implementation.



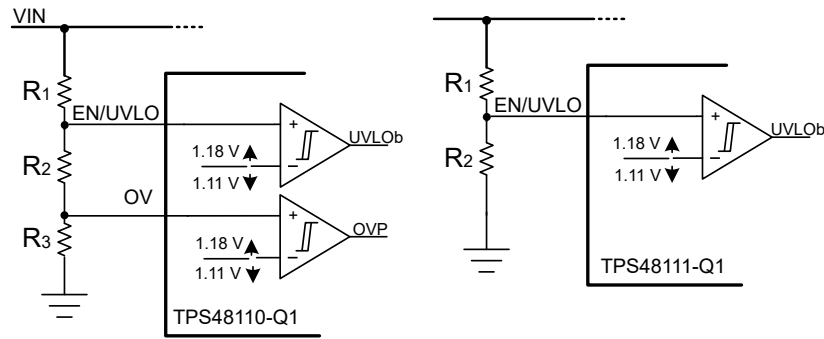
**图 8-11. Current sensing and Overcurrent protection**

### 8.3.6 Overvoltage (OV) and Undervoltage Protection (UVLO)

TPS4811x-Q1 has an accurate undervoltage protection ( $< \pm 2\%$ ) using EN/UVLO pin.

TPS48110-Q1 has an accurate overvoltage protection ( $< \pm 2\%$ ), providing robust load protection. Connect a resistor ladder as shown in 图 8-12 for undervoltage and overvoltage protection threshold programming.





### 图 8-12. Programming Overvoltage and Undervoltage Protection Threshold

### 8.3.7 Device Functional Mode (Shutdown Mode)

The TPS4811x-Q1 has two modes of operation. Active mode and low IQ shutdown mode. If the EN/UVLO pin voltage is greater than the rising threshold, then the device is in active mode. In active state the internal charge pump is enabled, gate drivers and all the protection and diagnostic features are enabled.

If the EN/UVLO voltage is pulled  $< V_{(ENF)}$ , the device enters into low IQ shutdown mode. In this mode, the charge pump, gate drivers and all the protection features are disabled. The external FETs turn OFF. The TPS4811x-Q1 consumes low IQ of 1.6  $\mu A$  (typical) in this mode.

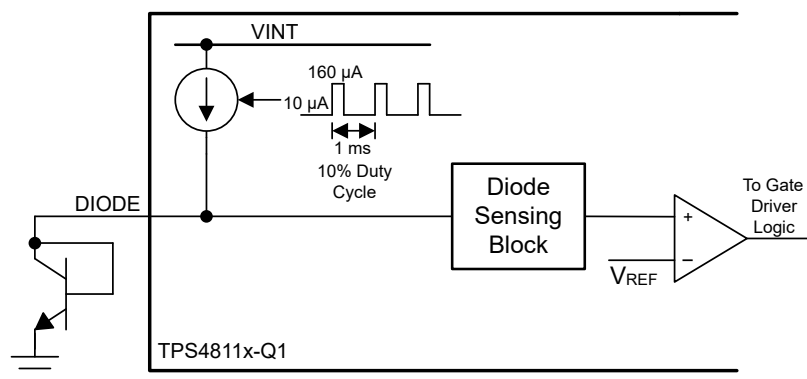
### 8.3.8 Remote Temperature sensing and Protection (DIODE)

The device features an integrated remote temperature sensing, protection and dedicated fault output. In TPS4811x-Q1, remote temperature measurement is done by using external transistor in diode configuration. Connect the DIODE pin of TPS4811x-Q1 to the collector and base of an MMBT3904 BJT. The temperature is calculated internally based on difference of measured diode voltages at two test currents.

In TPS48110-Q1, after the sensed temperature reaches 150°C, the device pulls PD low to SRC, turning off the external FET and asserts `FLT_T` low. After the temperature reduces to 130°C, an internally fixed auto-retry cycle of 512 ms commences. `FLT_T` de-asserts and the external FET turns ON after the retry duration of 512 ms is lapsed.

In TPS48111-Q1, after the sensed temperature crosses 150°C, PD and G get pulled low to SRC. After the TSD hysteresis, PU and G stays latched OFF. Latch gets reset by toggling EN/UVLO below  $V_{(ENF)}$  or by power cycling VS below  $V_{(VS PORF)}$ .

图 8-13 shows simplified block diagram of TPS4811x-Q1 DIODE based remote temperature sensing.



**图 8-13. DIODE based Remote Temperature Sensing Block Diagram**



### 8.3.9 Output Reverse Polarity Protection

The TPS4811x-Q1 withstands output reverse voltages down to -30 V. With INP low, PD is pulled low to SRC and keeps the external FET OFF even with output (SRC) voltage at negative levels preventing high current flow and protecting the main FET. Refer to 图 8-14 and 图 8-15 for test waveforms.

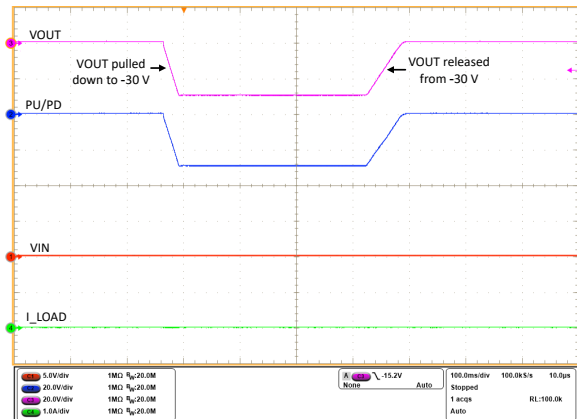


图 8-14. Output Short to -30 V Response with VIN = 0 V and INP = LOW

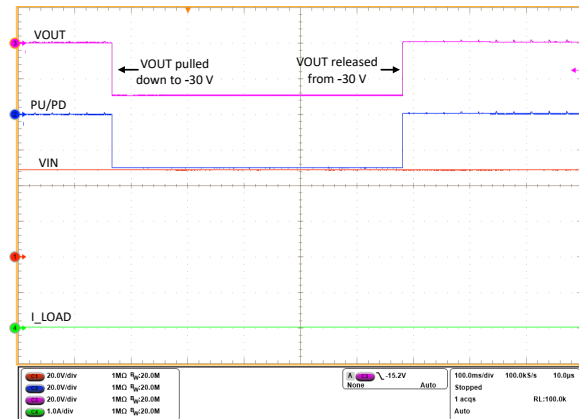


图 8-15. Output Short to -30 V Response with VIN = 48 V and INP = LOW

### 8.3.10 TPS4811x-Q1 as a Simple Gate Driver

图 8-16 shows application schematics of TPS4811x-Q1 as a simple gate driver in load disconnect switch as well as back-to-back FETs driving topologies. The protection features like two-level overcurrent protection, overvoltage protection, and overtemperature protection are disabled.

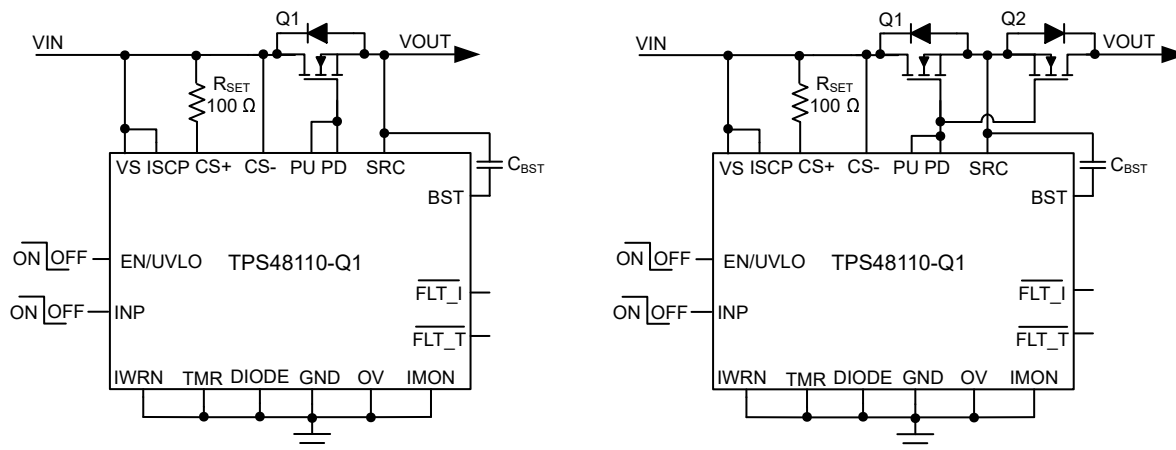


图 8-16. Connection Diagram of TPS48110-Q1 for Simple Gate Driver Design



## 9 Application and Implementation

### 备注

以下应用部分中的信息不属于 TI 器件规格的范围，TI 不担保其准确性和完整性。TI 的客户应负责确定器件是否适用于其应用。客户应验证并测试其设计，以确保系统功能。

### 9.1 Application Information

The TPS4811x-Q1 family is a 100-V smart high side driver with protection and diagnostics. The TPS4811x-Q1 device controls external N-channel MOSFETs and its drive architecture is suitable to drive back-to-back N-Channel MOSFETs. The strong gate 3.7-A peak source and 4-A peak sink capabilities enable switching parallel MOSFETs in high current applications such as circuit breaker in Powertrain (DC/DC converter), Battery Management System, Electric Power Steering, and driving PTC heater loads etc. The TPS4811x-Q1 device provides two-level adjustable overcurrent protection with adjustable circuit breaker timer, fast short-circuit protection, accurate analog current monitor output, and remote overtemperature protection.

The variant TPS48111-Q1 features a separate pre-charge driver (G) with independent control input (INP\_G). This feature enables system designs that need to pre-charge the large output capacitance before turning ON the main power path.

The following design procedure can be used to select the supporting component values based on the application requirement. Additionally, a spreadsheet design tool [TPS4811-Q1 Design Calculator](#) is available in the web product folder.

### 9.2 Typical Application: Driving HVAC PTC Heater Load on KL40 Line in Power Distribution Unit

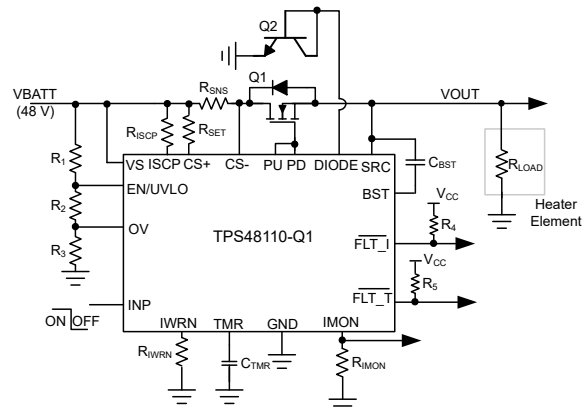


图 9-1. Typical Application Schematic: Driving HVAC PTC Heater



## 9.2.1 Design Requirements

表 9-1 shows the design parameters for this application example.

**表 9-1. Design Parameters**

PARAMETER	VALUE
Typical input voltage, $V_{IN}$	48 V
Undervoltage lockout set point, $V_{IN_{UVLO}}$	24 V
OV set point, $V_{IN_{OVP}}$	58 V
Maximum load current, $I_{OUT}$	12 A
Overcurrent protection threshold, $I_{OC}$	15 A
Short-circuit protection threshold, $I_{SC}$	20 A
Fault timer period ( $t_{OC}$ )	1 ms
Fault response	Auto-retry
Load resistance, $R_{LOAD}$	$4 \pm 0.2 \Omega$
Load switching frequency, $F_{SW}$	100 Hz

## 9.2.2 Detailed Design Procedure

### Selection of Current Sense Resistor, $R_{SNS}$

The recommended range of the overcurrent protection threshold voltage,  $V_{(SNS\_WRN)}$ , extends from 10 mV to 200 mV. Values near the low threshold of 10 mV can be affected by the system noise. Values near the upper threshold of 200 mV can cause high power dissipation in the current sense resistor. To minimize both the concerns, 25 mV is selected as the overcurrent protection threshold voltage. The current sense resistor,  $R_{SNS}$  can be calculated using 方程式 13.

$$R_{SNS} = \frac{V_{(SNS\_WRN)}}{I_{OC}} = \frac{25 \text{ mV}}{15 \text{ A}} = 1.66 \text{ m}\Omega \quad (13)$$

The next smaller available sense resistor 1.5 m $\Omega$ , 1% is chosen.

### Selection of Scaling Resistor, $R_{SET}$

$R_{SET}$  is the resistor connected between VS and CS+ pins. This resistor scales the overcurrent protection threshold voltage and coordinates with  $R_{IWRN}$  and  $R_{IMON}$  to determine the overcurrent protection threshold and current monitoring output. The recommended range of  $R_{SET}$  is 50  $\Omega$  - 100  $\Omega$ .

$R_{SET}$  is selected as 100  $\Omega$ , 1% for this design example.

### Programming the Overcurrent Protection Threshold - $R_{IWRN}$ Selection

The  $R_{IWRN}$  sets the overcurrent protection (circuit breaker detection) threshold, whose value can be calculated using 方程式 14.

$$R_{IWRN} (\Omega) = \frac{11.9 \times R_{SET}}{R_{SNS} \times I_{OC}} \quad (14)$$

To set 15 A as overcurrent protection threshold,  $R_{IWRN}$  value is calculated to be 52.88 k $\Omega$ .



Choose the closest available standard value: 54 k $\Omega$ , 1%

### Programming the Short-Circuit Protection Threshold - $R_{ISCP}$ Selection

The  $R_{ISCP}$  sets the short-circuit protection threshold, whose value can be calculated using 方程式 15.

$$R_{ISCP} (\Omega) = \frac{I_{SC} \times R_{SNS}}{15.6 \mu} - 600 \quad (15)$$

To set 20 A as short-circuit protection threshold,  $R_{ISCP}$  value is calculated to be 1.32 k $\Omega$ .

Choose the closest available standard value: 1.3 k $\Omega$ , 1%.

In case where large di/dt is involved, the system and layout parasitic inductances can generate large differential signal voltages between ISCP and CS- pins. This action can trigger false short-circuit protection and nuisance trips in the system. To overcome such scenario, TI recommends to add filter capacitor of 1 nF across ISCP and CS- pins close to the device. Because nuisance trips are dependent on the system and layout parasitics, TI recommends to test the design in a real system and tweaked as necessary.

### Programming the Fault timer Period - $C_{TMR}$ Selection

For the design example under discussion, overcurrent transients are allowed for 1-ms duration. This blanking interval,  $t_{OC}$  (or circuit breaker interval,  $T_{CB}$ ) can be set by selecting appropriate capacitor  $C_{TMR}$  from TMR pin to ground. The value of  $C_{TMR}$  to set 1 ms for  $t_{OC}$  can be calculated using 方程式 16.

$$C_{TMR} = \frac{82 \mu \times t_{OC}}{1.2} = 68.33 \text{ nF} \quad (16)$$

Choose closest available standard value: 68 nF, 10%.

### Selection of MOSFET, $Q_1$

For selecting the MOSFET  $Q_1$ , important electrical parameters are the maximum continuous drain current  $I_D$ , the maximum drain-to-source voltage  $V_{DS(MAX)}$ , the maximum drain-to-source voltage  $V_{GS(MAX)}$ , and the drain-to-source ON resistance  $R_{DS(ON)}$ .

The maximum continuous drain current,  $I_D$ , rating must exceed the maximum continuous load current.

The maximum drain-to-source voltage,  $V_{DS(MAX)}$ , must be high enough to withstand the highest voltage seen in the application. Considering 60 V as the maximum application voltage, MOSFETs with  $V_{DS}$  voltage rating of 80 V is suitable for this application.

The maximum  $V_{GS}$  TPS4811-Q1 can drive is 13 V, so a MOSFET with 15-V minimum  $V_{GS}$  rating must be selected.

To reduce the MOSFET conduction losses, lowest possible  $R_{DS(ON)}$  is preferred.

Based on the design requirements, IPB160N08S4-03ATMA1 is selected and its ratings are:

- 80-V  $V_{DS(MAX)}$  and  $\pm 20$ -V  $V_{GS(MAX)}$
- $R_{DS(ON)}$  is 2.6-m $\Omega$  typical at 10-V  $V_{GS}$
- MOSFET  $Q_{g(total)}$  is 86 nC

### Selection of Bootstrap Capacitor, $C_{BST}$

The internal charge pump charges the external bootstrap capacitor (connected between BST and SRC pins) with approximately 100  $\mu$  A. In case of switching applications, the BST must be powered externally from  $V_{AUX}$  supply



(ranging between 8.1 V to 15 V) through a low-leakage silicon diode such as CMHD3595 or BAT46WH,115 to avoid collapsing the BST-SRC supply. This need is determined by the value of the switching frequency and MOSFET gate charge.

The maximum possible frequency without external supply is given by [方程式 17](#).

$$F_{SW,max} = \frac{I_{(BST)}}{2 \times Q_{g(total)}} = 581 \text{ Hz} \quad (17)$$

As the present application is switched at 100 Hz, external supply is not required. Use the following equation to calculate the minimum required value of the bootstrap capacitor for driving two parallel BUK7S0R5-40HJ MOSFETs.

$$C_{BST} = \frac{Q_{g(total)}}{1 \text{ V}} = 380 \text{ nF} \quad (18)$$

Choose closest available standard value: 470 nF, 10 %.

### **Setting the Undervoltage Lockout and Overvoltage Set Point**

The undervoltage lockout (UVLO) and overvoltage set point are adjusted using an external voltage divider network of  $R_1$ ,  $R_2$  and  $R_3$  connected between VS, EN/UVLO, OVP and GND pins of the device. The values required for setting the undervoltage and overvoltage are calculated by solving [方程式 19](#) and [方程式 20](#).

$$V_{(OVR)} = \frac{R_3}{(R_1 + R_2 + R_3)} \times V_{IN_{OVP}} \quad (19)$$

$$V_{(UVLOR)} = \frac{R_2 + R_3}{(R_1 + R_2 + R_3)} \times V_{IN_{UVLO}} \quad (20)$$

For minimizing the input current drawn from the power supply, TI recommends to use higher values of resistance for  $R_1$ ,  $R_2$  and  $R_3$ . However, leakage currents due to external active components connected to the resistor string can add error to these calculations. So, the resistor string current,  $I(R_{123})$  must be chosen to be 20 times greater than the leakage current of UVLO and OVP pins.

From the device electrical specifications,  $V_{(OVR)} = 1.18 \text{ V}$  and  $V_{(UVLOR)} = 1.18 \text{ V}$ . From the design requirements,  $V_{IN_{OVP}}$  is 58 V and  $V_{IN_{UVLO}}$  is 24 V. To solve the equation, first choose the value of  $R_1 = 470 \text{ k}\Omega$  and use [方程式 20](#) to solve for  $(R_2 + R_3) = 24.3 \text{ k}\Omega$ . Use [方程式 19](#) and value of  $(R_2 + R_3)$  to solve for  $R_3 = 10.1 \text{ k}\Omega$  and finally  $R_2 = 14.2 \text{ k}\Omega$ . Choose the closest standard 1 % resistor values:  $R_1 = 470 \text{ k}\Omega$ ,  $R_2 = 14.3 \text{ k}\Omega$ , and  $R_3 = 10.2 \text{ k}\Omega$ .

### **Choosing the Current Monitoring Resistor, $R_{IMON}$**

Voltage at IMON pin  $V_{(IMON)}$  is proportional to the output load current. This can be connected to an ADC of the downstream system for monitoring the operating condition and health of the system. The  $R_{IMON}$  must be selected based on the maximum load current and the input voltage range of the ADC used.  $R_{IMON}$  is set using [方程式 21](#).

$$V_{(IMON)} = \left( V_{SNS} + V_{(OS\_SET)} \right) \times \frac{0.9 \times R_{IMON}}{R_{SET}} \quad (21)$$

Where  $V_{SNS} = I_{OC} \times R_{SNS}$  and  $V_{(OS\_SET)}$  is the input referred offset ( $\pm 200 \mu\text{V}$ ) of the current sense amplifier.

For  $I_{OC} = 15 \text{ A}$  and considering the operating range of ADC to be 0 V to 3.3 V (for example,  $V_{(IMON)} = 3.3 \text{ V}$ ),  $R_{IMON}$  can be calculated as



$$R_{\text{IMON}} = \frac{V_{(\text{IMON})} \times R_{\text{SET}}}{(V_{\text{SNS}} + V_{(\text{OS\_SET})}) \times 0.9} = 16.52 \text{ k}\Omega \quad (22)$$

Selecting  $R_{\text{IMON}}$  value less than shown in 方程式 22 ensures that ADC limits are not exceeded for maximum value of load current. Choose the closest available standard value: 16.5 k $\Omega$ , 1%.



### 9.2.3 Application Curves

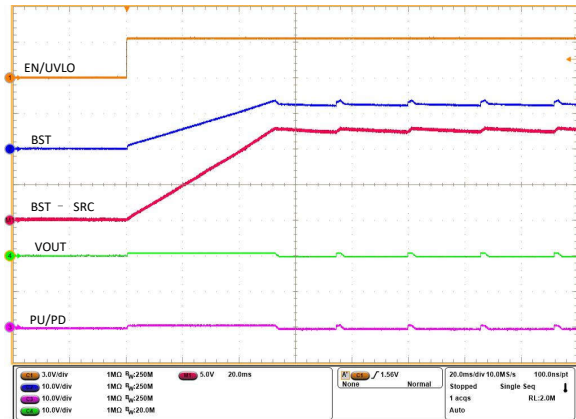


图 9-2. Start-Up Profile of Bootstrap Voltage for INP = GND and  $C_{BST} = 470 \text{ nF}$

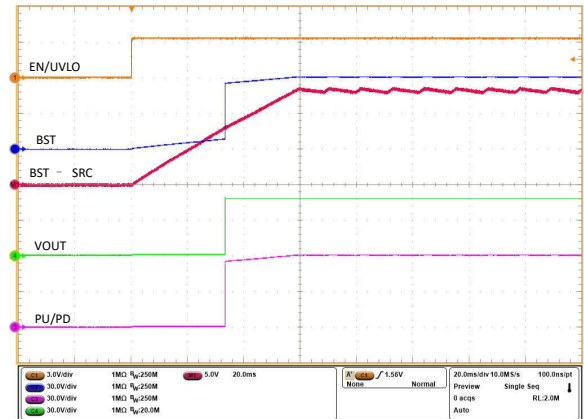


图 9-3. Start-Up Profile of Bootstrap Voltage for INP = HIGH and  $C_{BST} = 470 \text{ nF}$

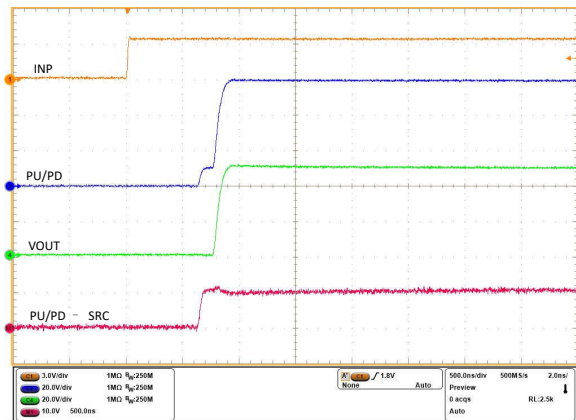


图 9-4. Turn-ON Response of TPS48110-Q1 for INP -> LOW to HIGH and  $C_{BST} = 470 \text{ nF}$

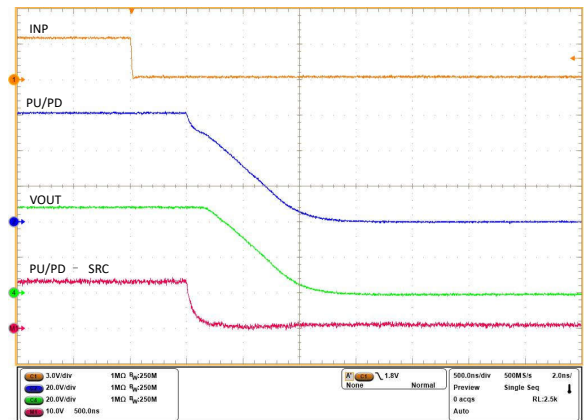


图 9-5. Turn-OFF Response of TPS48110-Q1 for INP -> HIGH to LOW and  $C_{BST} = 470 \text{ nF}$

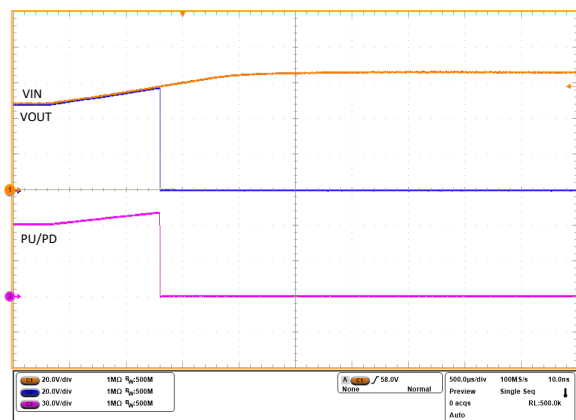


图 9-6. Overvoltage Cut-off Response at 58-V Level of TPS48110-Q1

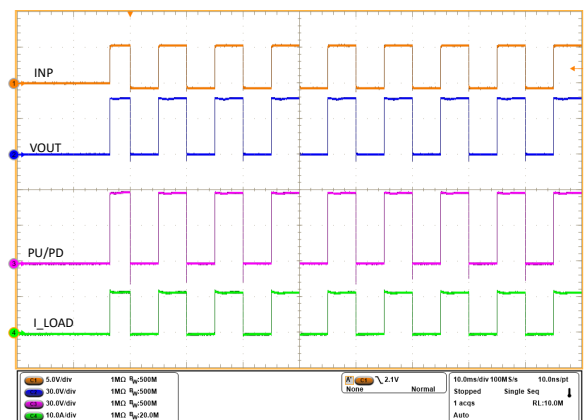


图 9-7. Load Switching at 100 Hz With TPS48110-Q1



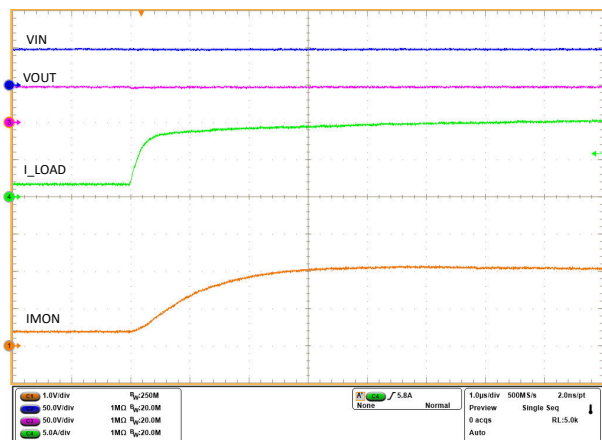


图 9-8. IMON Response During 10-A Load Step

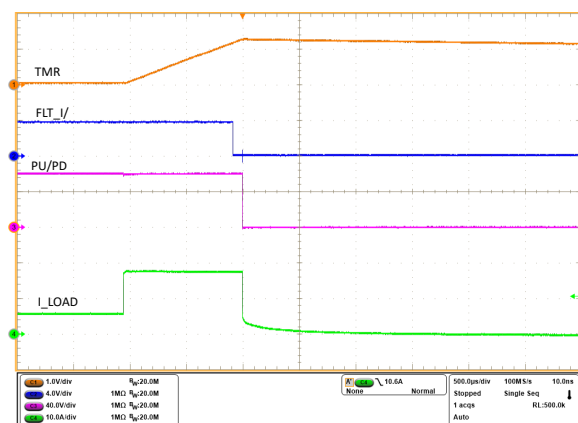


图 9-9. Overcurrent Response of TPS48110-Q1 for a Load Step from 5 A to 18 A With 15-A Overcurrent Protection Setting

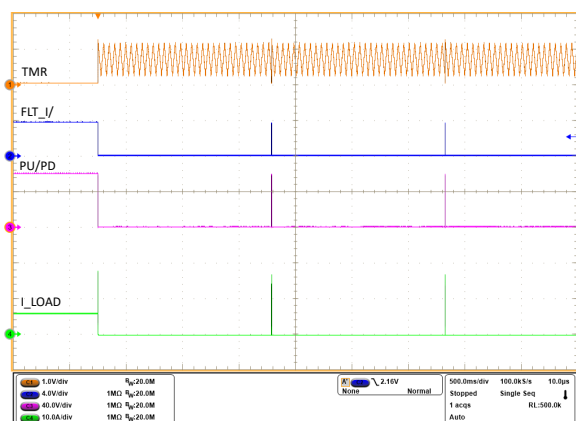


图 9-10. Auto-Retry Response of TPS48110-Q1 for an Overcurrent Fault

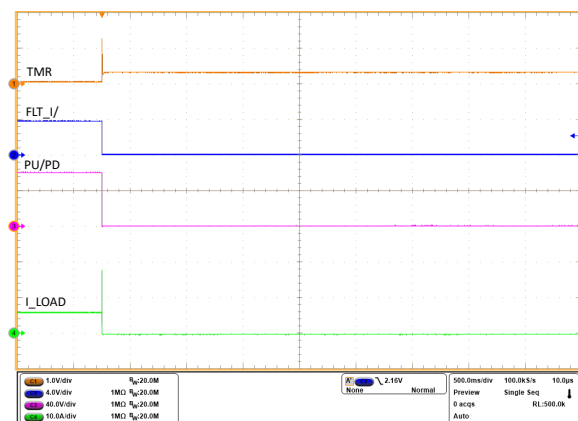


图 9-11. Latch-off Response of TPS48110-Q1 for an Overcurrent Fault

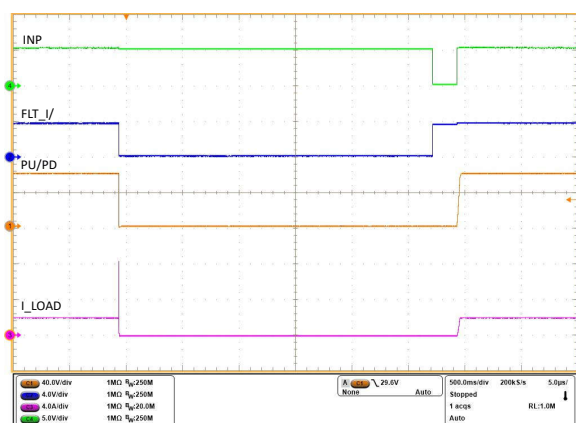


图 9-12. Response During Coming Out of Overload Fault With INP Reset

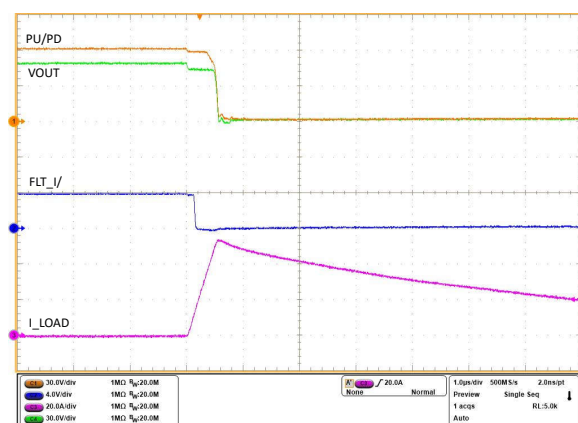


图 9-13. Output Hot-Short Response of the TPS48110-Q1 Device



## 9.3 Typical Application: Driving B2B FETs With Pre-charging the Output Capacitance

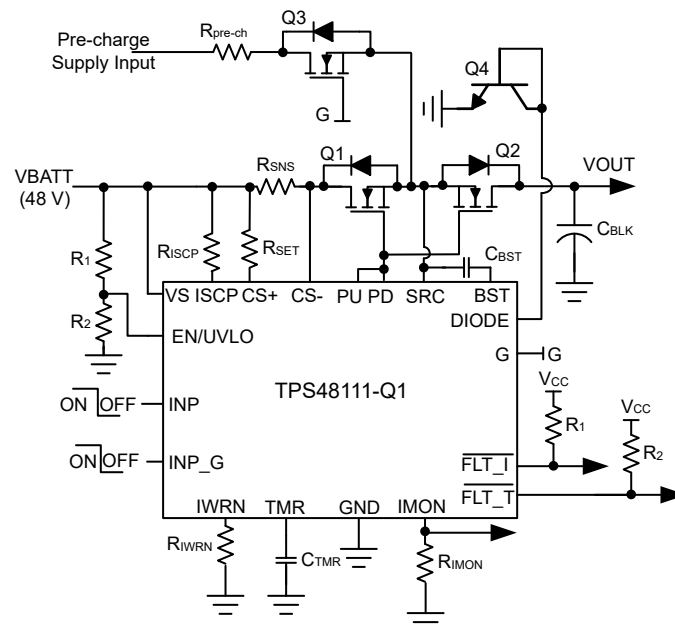


图 9-14. Typical Application Schematic: Driving DC-DC Converter Loads in Powertrain

### 9.3.1 Design Requirements

表 9-2 shows the design parameters for this application example.

表 9-2. Design Parameters

PARAMETER	VALUE
Typical input voltage, $V_{IN}$	48 V
Undervoltage lockout set point, $V_{INUVLO}$	24 V
Maximum load current, $I_{OUT}$	40 A
Overcurrent protection threshold, $I_{OC}$	50 A
Short-circuit protection threshold, $I_{SC}$	60 A
Fault timer period ( $t_{OC}$ )	1 ms
Fault response	Latch-off
Load capacitance, $C_{OUT}$	400 $\mu$ F
Inrush current limit, $I_{inrush}$	500 mA

### 9.3.2 External Component Selection

By following similar design procedure as outlined in [Detailed Design Procedure](#), the external component values are calculated as below:

- $R_{SNS} = 500 \mu \Omega$
- $R_{SET} = 100 \Omega$
- $R_{IWRN} = 47 k\Omega$  to set 50 A as overcurrent protection threshold
- $R_{ISCP} = 1.4 k\Omega$  to set 60 A as short-circuit protection threshold



- $C_{TMR} = 68 \text{ nF}$  to set 1 ms circuit breaker time
- $R_1$  and  $R_2$  are selected as  $470 \text{ k}\Omega$  and  $24.9 \text{ k}\Omega$  respectively to set  $V_{IN}$  undervoltage lockout threshold at 24 V
- $R_{IMON} = 15 \text{ k}\Omega$  to limit maximum  $V_{(IMON)}$  voltage to 3.3 V at full-load current of 50 A
- To reduce conduction losses, IAUS300N08S5N012 MOSFET is selected. Two FETs are used in parallel for control and another two FETs are used in parallel for reverse current blocking
  - 80-V  $V_{DS(MAX)}$  and  $\pm 20\text{-V } V_{GS(MAX)}$
  - $R_{DS(ON)}$  is  $1\text{-m}\Omega$  typical at  $10\text{-V } V_{GS}$
  - $Q_g$  of each MOSFET is 231 nC
- $C_{BST} = (4 \times Q_g) / 1 \text{ V} = 1 \text{ }\mu\text{F}$

### Selection of Pre-Charge Resistor

The value of pre-charge resistor must be selected to limit the inrush current to  $I_{inrush}$  as per 方程式 23.

$$R_{pre-ch} = \frac{V_{IN}}{I_{inrush}} = 96 \text{ }\Omega \quad (23)$$

The power rating of the pre-charge resistor is decided by the average power dissipation given by 方程式 24.

$$P_{avg} = \frac{E_{pre-ch}}{T_{pre-ch}} = \frac{0.5 \times C_{OUT} \times V_{IN}^2}{5 \times R_{pre-ch} \times C_{OUT}} = 2.4 \text{ W} \quad (24)$$

The peak power dissipation in the pre-charge resistor is given by 方程式 25.

$$P_{peak} = \frac{V_{IN}^2}{R_{pre-ch}} = 24 \text{ W} \quad (25)$$

Two  $220\text{-}\Omega$ , 1.5-W, 5% CRCW2512220RJNEGHP resistors are used in parallel to support both average and peak power dissipation.

TI suggests the designer to share the entire power dissipation profile of pre-charge resistor with the resistor manufacturer and get their recommendation.



### 9.3.3 Application Curves

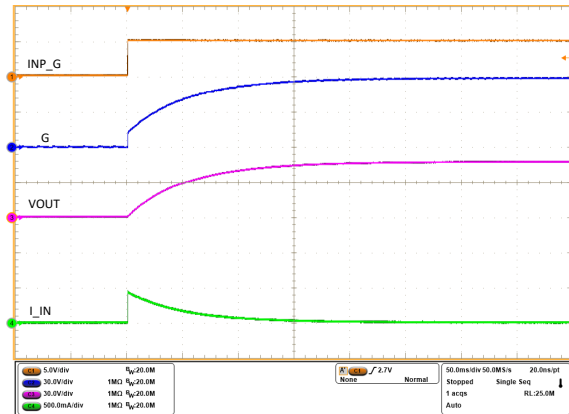


图 9-15. Pre-charge Profile of the Output Capacitance (VIN = 48 V, C<sub>OUT</sub> = 440 μF, No Load)

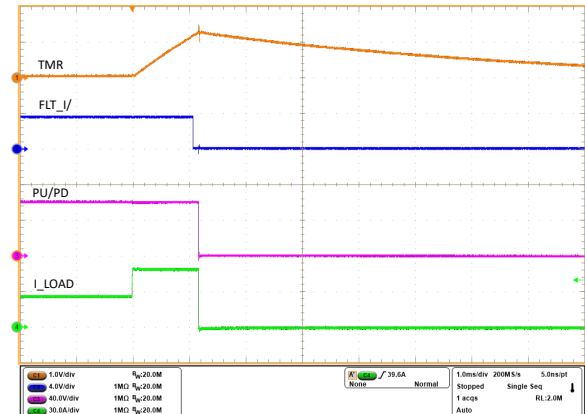


图 9-16. Overcurrent Response of TPS4811-Q1 for a Load Step from 24 A to 54 A With 50-A Overcurrent Protection Setting

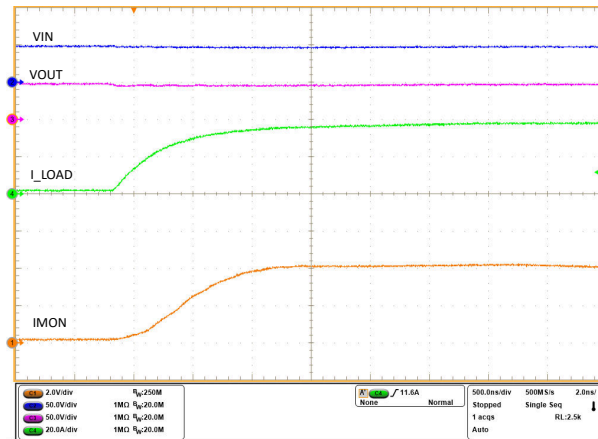


图 9-17. IMON Response During 40-A Load Step

## 9.4 Power Supply Recommendations

When the external MOSFETs turn OFF during the conditions such as INP control, overvoltage cutoff, overcurrent protection causing an interruption of the current flow, the input parasitic line inductance generates a positive voltage spike on the input and output parasitic inductance generates a negative voltage spike on the output. The peak amplitude of voltage spikes (transients) depends on the value of inductance in series to the input or output of the device. These transients can exceed the *Absolute Maximum Ratings* of the device if steps are not taken to address the issue. Typical methods for addressing transients include:

- Use of a TVS diode and input capacitor filter combination across input to and GND to absorb the energy and dampen the positive transients.
- Use of a diode or a TVS diode across the output and GND to absorb negative spikes.

The TPS4811-Q1 gets powered from the VS pin. Voltage at this pin must be maintained above  $V_{(VS\_PORR)}$  level to ensure proper operation. If the input power supply source is noisy with transients, then TI recommends to place a  $R_{VS}$  -  $C_{VS}$  filter between the input supply line and VS pin to filter out the supply noise. TI recommends  $R_{VS}$  value around 100 Ω.



In case where large  $di/dt$  is involved, the system and layout parasitic inductances can generate large differential signal voltages between ISCP and CS- pins. This action can trigger false short-circuit protection and nuisance trips in the system. To overcome such scenario, TI recommends to add filter capacitor of 1 nF ( $C_{SCP}$ ) across ISCP and CS- pins close to the device. Because nuisance trips are dependent on the system and layout parasitics, TI recommends to test the design in a real system and tweaked as necessary.

The following figure shows the circuit implementation with optional protection components.

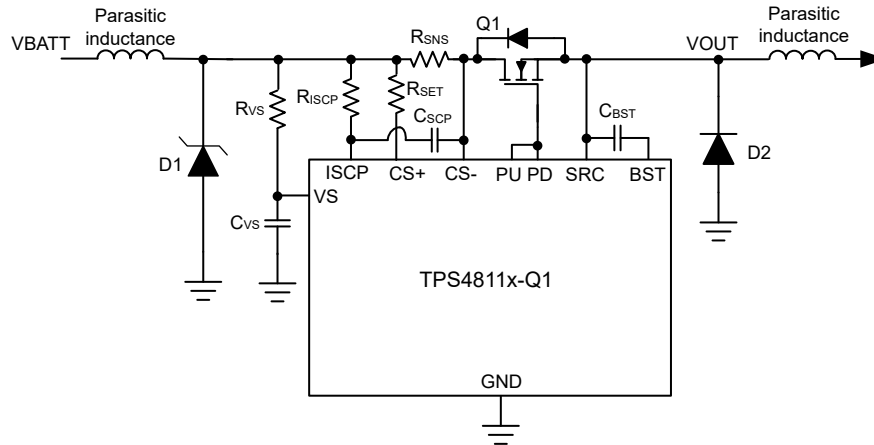


图 9-18. Circuit Implementation With Optional Protection Components for TPS4811-Q1

## 9.5 Layout

### 9.5.1 Layout Guidelines

- The sense resistor ( $R_{SNS}$ ) must be placed close to the TPS4811x-Q1 and then connect  $R_{SNS}$  using the Kelvin techniques. Refer to [Choosing the Right Sense Resistor Layout](#) for more information on the Kelvin techniques.
- For all the applications, TI recommends a 0.1  $\mu$ F or higher value ceramic decoupling capacitor between VS terminal and GND. Consider adding RC network at the supply pin (VS) of the controller to improve decoupling against the power line disturbances.
- The high current path from the board's input to the load, and the return path, must be parallel and close to each other to minimize loop inductance.
- The external MOSFETs must be placed close to the controller such that the GATE of the MOSFETs are close to PU/PD pins to form short GATE loop. Consider adding a place holder for a resistor in series with the Gate of each external MOSFET to damp high frequency oscillations if need arises.
- Place a TVS diode at the input to clamp the voltage transients during hot-plug and fast turn-off events.
- The external boot-strap capacitor must be placed close to BST and SRC pins to form very short loop.
- The ground connections for the various components around the TPS4811x-Q1 must be connected directly to each other, and to the TPS4811x-Q1's GND, and then connected to the system ground at one point. Do not connect the various component grounds to each other through the high current ground line.
- The DIODE pin sources current to measure the temperature. TI recommends BJT MMBT3904 to use as a remote temperature sense element. Take care in the PCB layout to keep the parasitic resistance between the DIODE pin and the MMBT3904 low so as not to degrade the measurement. In addition, TI recommends to make a Kelvin connection from the emitter of the MMBT3904 to the GND of the part to ensure an accurate measurement. Additionally, a small 1000 pF bypass capacitor must be placed in parallel with the MMBT3904 to reduce the effects of noise.







## 10 Device and Documentation Support

### 10.1 接收文档更新通知

要接收文档更新通知，请导航至 [ti.com](https://ti.com) 上的器件产品文件夹。点击 [通知](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

### 10.2 支持资源

**TI E2E™ 中文支持论坛** 是工程师的重要参考资料，可直接从专家处获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题，获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的 [使用条款](#)。

### 10.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.

所有商标均为其各自所有者的财产。

### 10.4 静电放电警告



静电放电 (ESD) 会损坏这个集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

### 10.5 术语表

**TI 术语表** 本术语表列出并解释了术语、首字母缩略词和定义。

## 11 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from Revision C (December 2022) to Revision D (April 2024)	Page
• Updated the DIODE sense TSD rising threshold, $T_{(DIODE\_TSD\_rising)}$ , specification in the <i>Electrical Characteristics</i> section.....	5
Changes from Revision B (September 2022) to Revision C (December 2022)	Page
• 将器件状态从 <i>预告信息</i> 更改为 <i>量产数据</i> .....	1

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



## PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
<a href="#">TPS48110AQDGXRQ1</a>	Active	Production	VSSOP (DGX)   19	5000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	2UZS
TPS48110AQDGXRQ1.A	Active	Production	VSSOP (DGX)   19	5000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	2UZS
<a href="#">TPS48111LQDGXRQ1</a>	Active	Production	VSSOP (DGX)   19	5000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	2XXS
TPS48111LQDGXRQ1.A	Active	Production	VSSOP (DGX)   19	5000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	2XXS

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

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## TAPE AND REEL INFORMATION



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS48110AQDGXRQ1	VSSOP	DGX	19	5000	330.0	16.4	5.4	5.4	1.45	8.0	16.0	Q1
TPS48111LQDGXRQ1	VSSOP	DGX	19	5000	330.0	16.4	5.4	5.4	1.45	8.0	16.0	Q1



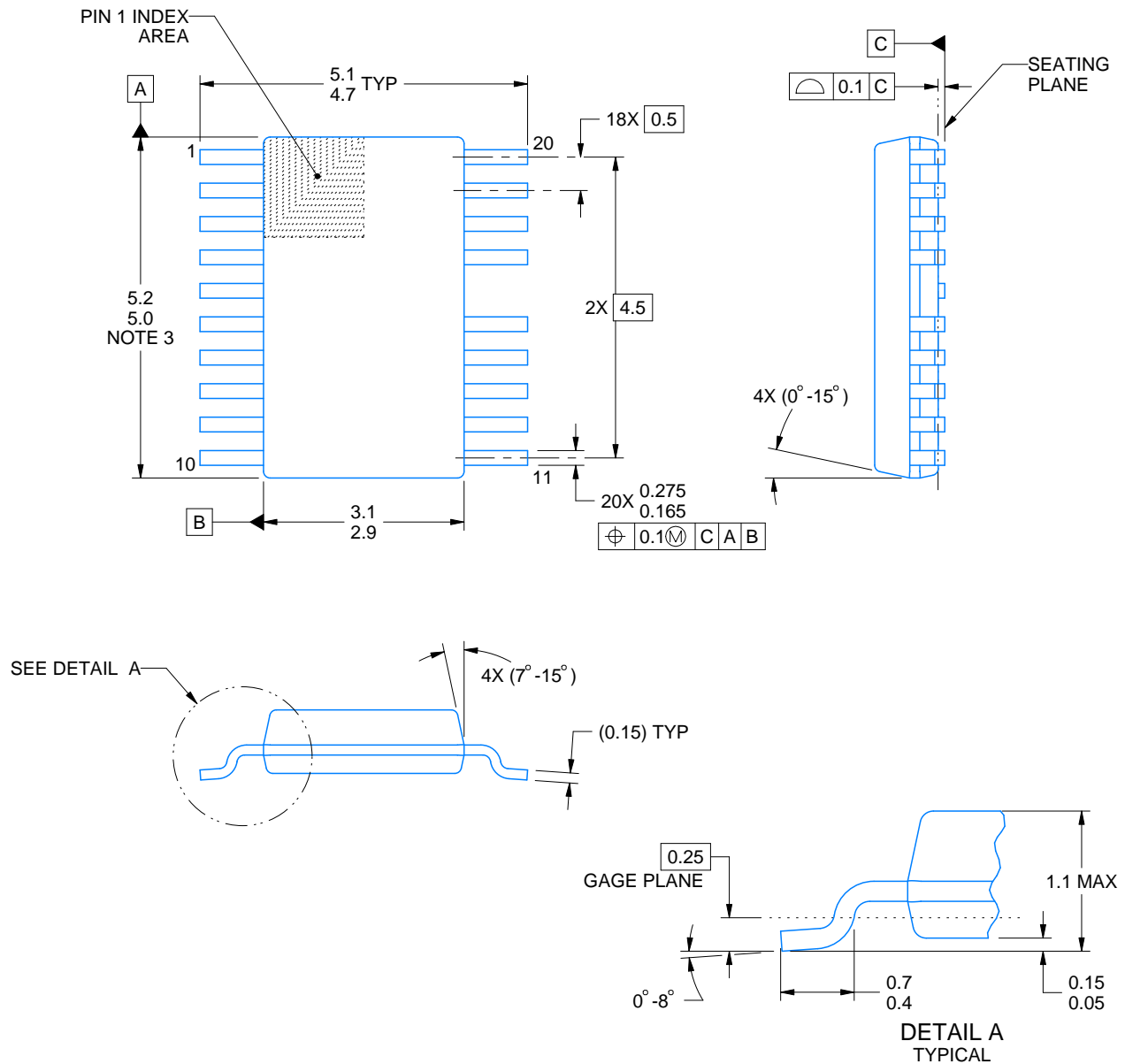
## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS48110AQDGXRQ1	VSSOP	DGX	19	5000	353.0	353.0	32.0
TPS48111LQDGXRQ1	VSSOP	DGX	19	5000	353.0	353.0	32.0





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**NOTES:**

PowerPAD is a trademark of Texas Instruments.

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. No JEDEC registration as of July 2021.
5. Features may differ or may not be present.

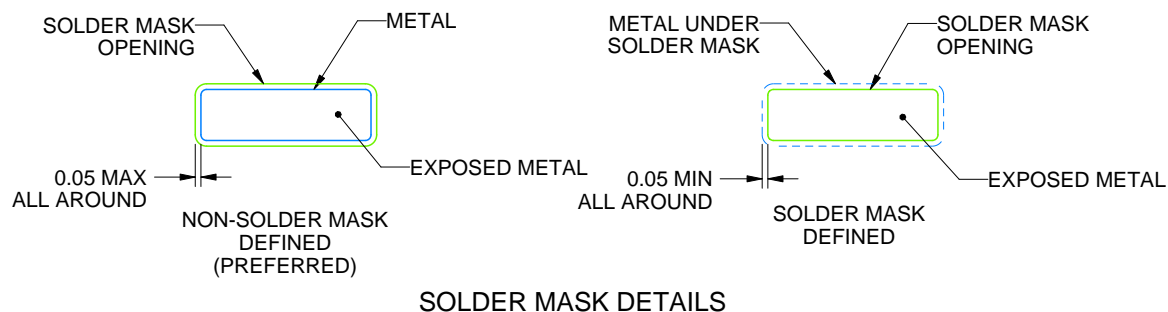
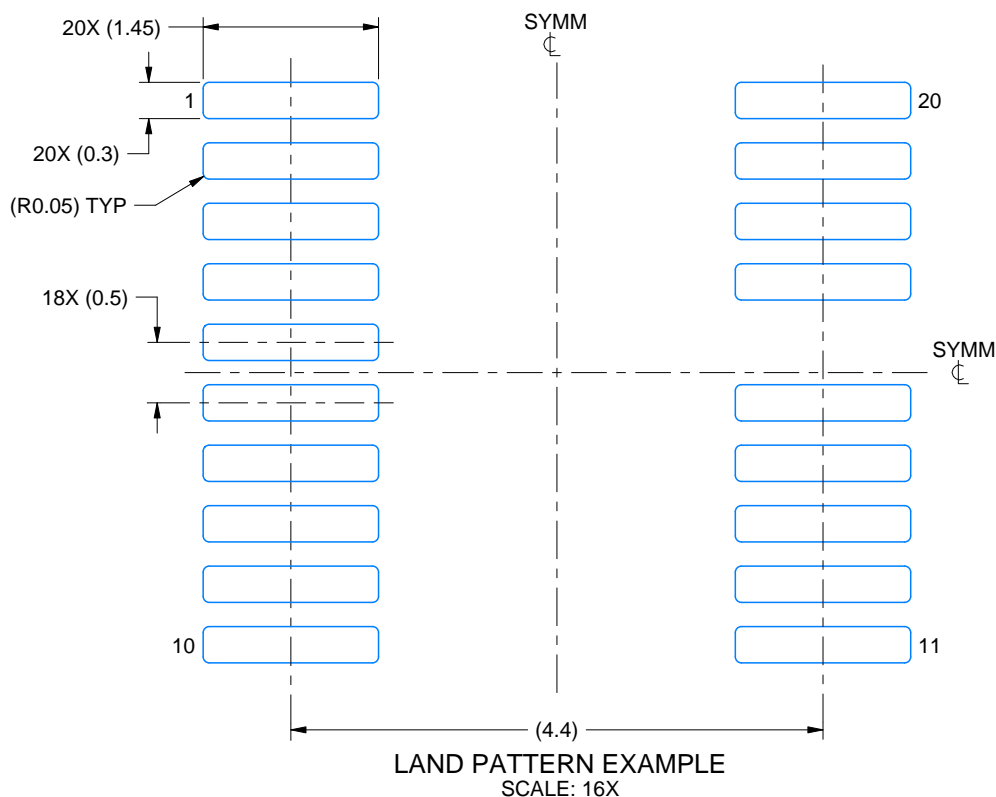


# EXAMPLE BOARD LAYOUT

DGX0019A

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



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NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature numbers SLMA002 ([www.ti.com/lit/slma002](http://www.ti.com/lit/slma002)) and SLMA004 ([www.ti.com/lit/slma004](http://www.ti.com/lit/slma004)).
9. Size of metal pad may vary due to creepage requirement.
10. Vias are optional depending on application, refer to device data sheet. It is recommended that vias under paste be filled, plugged or tented.

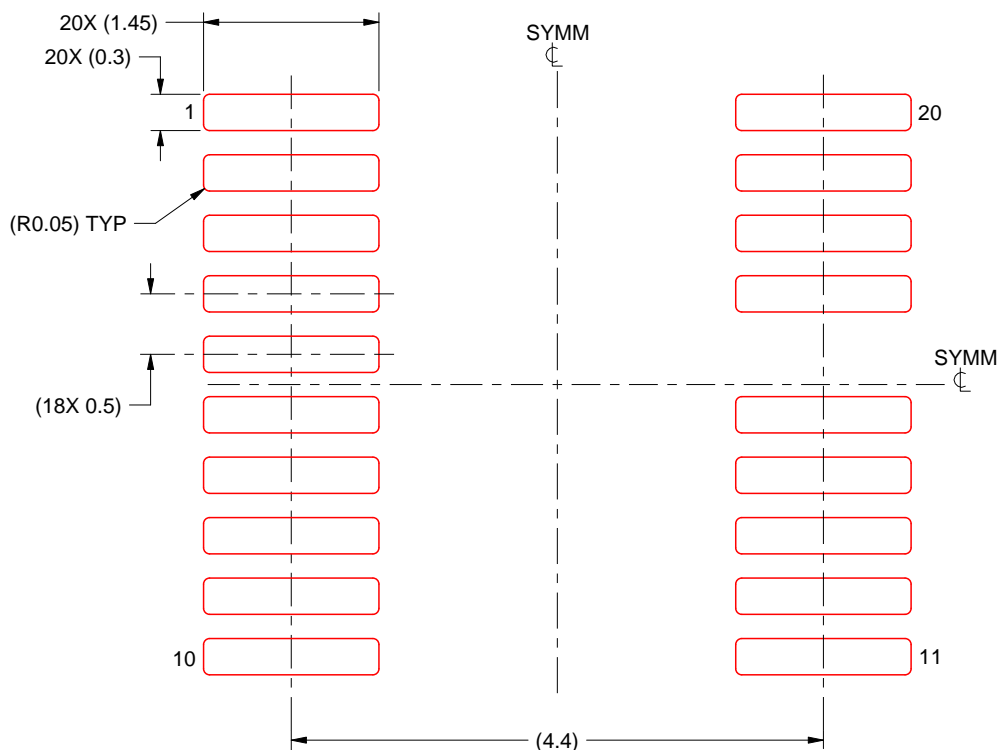


# EXAMPLE STENCIL DESIGN

DGX0019A

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE: 16X

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NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
12. Board assembly site may have different recommendations for stencil design.



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